

# TMUX13xxA 5V, Bidirectional 8:1, 1-Channel and 4:1, 2-Channel Current Injection Controlled Multiplexers Optimized for High-Impedance Loads

## 1 Features

- [Injection current control](#)
- [Back-powering protection](#)
  - No ESD diode path to  $V_{DD}$
- Wide supply range: 1.62V to 5.5V
- Low ON-capacitance
- [Bidirectional signal path](#)
- [Optimized for high-impedance loads](#)
- [Rail-to-rail operation](#)
- [1.8V logic compatible](#)
- [Fail-safe logic](#)
- Break-before-make switching
- [Short-to-battery protection for ON and OFF channels](#)
- [Functional safety-capable](#)
  - [Documentation available to aid functional safety system design](#)
- TMUX1308A – pin compatible with:
  - Industry standard 4051, 4851 and 1308 multiplexers
- TMUX1309A – pin compatible with:
  - Industry standard 4052, 4852 and 1309 multiplexers

## 2 Applications

- Analog and digital multiplexing and demultiplexing
- Diagnostics and monitoring
- [Data center switch](#)
- [Remote radio unit \(RRU\)](#)
- [Rack server](#)
- [Electricity meter](#)
- [Appliances](#)
- [Air conditioner units](#)
- [Multifunction printers](#)
- [String inverter](#)
- [IP network camera](#)
- [Currency counters](#)
- [Off-highway vehicles control systems](#)

## 3 Description

The TMUX1308A and TMUX1309A are general purpose complementary metal-oxide semiconductor (CMOS) multiplexers (MUX). The TMUX1308A is an 8:1, 1-channel (single-ended) mux, while the TMUX1309A is a 4:1, 2-channel (differential) mux. The devices support bidirectional analog and digital signals on the source (Sx) and drain (Dx) pins ranging from GND to  $V_{DD}$ .

The TMUX13xxA devices have an internal injection current control feature, which eliminates the need for external diode and resistor networks typically used to protect the switch and keep the input signals within the supply voltage. The internal injection current control circuitry allows signals on disabled or enabled signal paths to exceed the supply voltage. Disabled channels with voltages above  $V_{DD}$  are prevented from affecting the signal of the enabled signal path. Additionally, the TMUX13xxA devices do not have an internal diode path to the supply pin, which eliminates the risk of damaging components connected to the supply pin or providing unintended power to the supply rail.

All logic inputs have [1.8V logic compatible](#) thresholds, allowing for both TTL and CMOS logic compatibility when operating with a valid supply voltage. [Fail-Safe Logic](#) circuitry allows voltages on the control pins to be applied before the supply pin, protecting the device from potential damage.

### Device Information

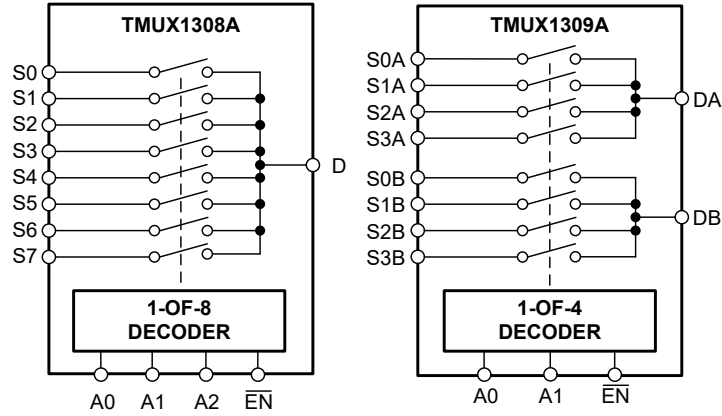
| PART NUMBER | CONFIGURATION <sup>(1)</sup> | PACKAGE <sup>(2)</sup> | BODY SIZE (NOM) <sup>(3)</sup> |
|-------------|------------------------------|------------------------|--------------------------------|
| TMUX1308A   | Channel 8:1                  | PW (TSSOP, 16)         | 5mm × 4.4mm                    |
| TMUX1309A   | Channel 4:1                  |                        |                                |

(1) See the [Device Comparison Table](#).

(2) For more information, see [Section 11](#).

(3) The body size (length × width) is a nominal value and does not include pins.





**TMUX1308A and TMUX1309A Block Diagram**

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## 4 Device Comparison Table

| PRODUCT   | DESCRIPTION                              |
|-----------|--|
| TMUX1308A | 8:1, 1-channel, single-ended multiplexer |
| TMUX1309A | 4:1, 2-channel, differential multiplexer |

## 5 Pin Configuration and Functions

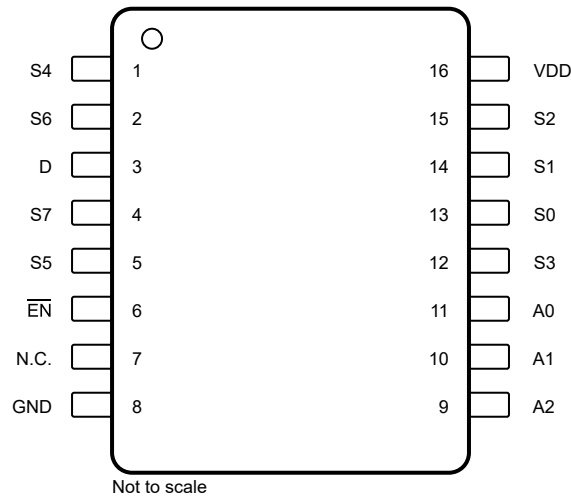


Figure 5-1. TMUX1308A: PW Package, 16-Pin TSSOP (Top View)

Table 5-1. Pin Functions TMUX1308A

| PIN                    |     | TYPE <sup>(1)</sup> | DESCRIPTION <sup>(2)</sup>  |
|------------------------|-----|---------------------|---|
| NAME                   | NO. |                     |   |
| S4                     | 1   | I/O                 | Source pin 4. Signal path can be an input or output.  |
| S6                     | 2   | I/O                 | Source pin 6. Signal path can be an input or output.  |
| D                      | 3   | I/O                 | Drain pin (common). Signal path can be an input or output.  |
| S7                     | 4   | I/O                 | Source pin 7. Signal path can be an input or output.  |
| S5                     | 5   | I/O                 | Source pin 5. Signal path can be an input or output.  |
| $\overline{\text{EN}}$ | 6   | I                   | Active low logic input. When this pin is high, all switches are turned off. When this pin is low, the A[2:0] address inputs determine which switch is turned on as listed in <a href="#">Section 8.5</a> .              |
| N.C.                   | 7   | Not Connected       | Not internally connected.   |
| GND                    | 8   | P                   | Ground (0V) reference   |
| A2                     | 9   | I                   | Address line 2. Controls the switch configuration as listed in <a href="#">Section 8.5</a> .  |
| A1                     | 10  | I                   | Address line 1. Controls the switch configuration as listed in <a href="#">Section 8.5</a> .  |
| A0                     | 11  | I                   | Address line 0. Controls the switch configuration as listed in <a href="#">Section 8.5</a> .  |
| S3                     | 12  | I/O                 | Source pin 3. Signal path can be an input or output.  |
| S0                     | 13  | I/O                 | Source pin 0. Signal path can be an input or output.  |
| S1                     | 14  | I/O                 | Source pin 1. Signal path can be an input or output.  |
| S2                     | 15  | I/O                 | Source pin 2. Signal path can be an input or output.  |
| VDD                    | 16  | P                   | Positive power supply. This pin is the most positive power-supply potential. For reliable operation, connect a decoupling capacitor ranging from 0.1 $\mu\text{F}$ to 10 $\mu\text{F}$ between V <sub>DD</sub> and GND. |
| Thermal pad            |     | —                   | Exposed thermal pad with conductive die attached. No requirement to solder this pad. If connected, then it should be left floating or tied to GND.  |

(1) I = input, O = output, I/O = input and output, P = power.

(2) For what to do with unused pins, refer to [Section 8.4](#).

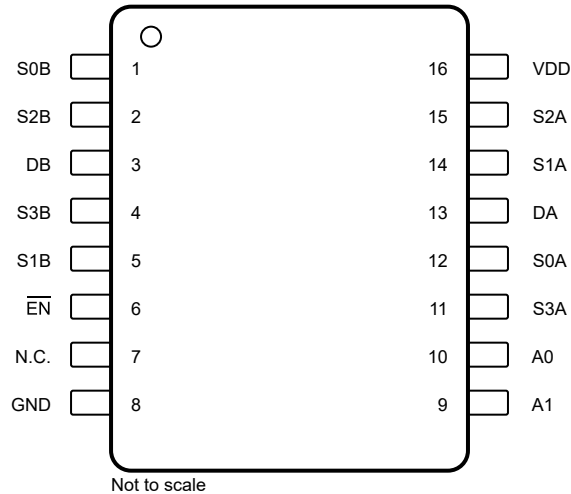


Figure 5-2. TMUX1309A: PW Package, 16-Pin TSSOP (Top View)

Table 5-2. Pin Functions TMUX1309A

| PIN                    |     | TYPE <sup>(1)</sup> | DESCRIPTION <sup>(2)</sup>  |
|------------------------|-----|---------------------|---|
| NAME                   | NO. |                     |   |
| S0B                    | 1   | I/O                 | Source pin 0 of mux B. Can be an input or output.   |
| S2B                    | 2   | I/O                 | Source pin 2 of mux B. Can be an input or output.   |
| DB                     | 3   | I/O                 | Drain pin (Common) of mux B. Can be an input or output.   |
| S3B                    | 4   | I/O                 | Source pin 3 of mux B. Can be an input or output.   |
| S1B                    | 5   | I/O                 | Source pin 1 of mux B. Can be an input or output.   |
| $\overline{\text{EN}}$ | 6   | I                   | Active low logic input. When this pin is high, all switches are turned off. When this pin is low, the A[1:0] address inputs determine which switch is turned on.  |
| N.C.                   | 7   | Not Connected       | Not internally connected.   |
| GND                    | 8   | P                   | Ground (0V) reference   |
| A1                     | 9   | I                   | Address line 1. Controls the switch configuration as listed in <a href="#">Section 8.5</a> .  |
| A0                     | 10  | I                   | Address line 0. Controls the switch configuration as listed in <a href="#">Section 8.5</a> .  |
| S3A                    | 11  | I/O                 | Source pin 3 of mux A. Can be an input or output.   |
| S0A                    | 12  | I/O                 | Source pin 0 of mux A. Can be an input or output.   |
| DA                     | 13  | I/O                 | Drain pin (Common) of mux A. Can be an input or output.   |
| S1A                    | 14  | I/O                 | Source pin 1 of mux A. Can be an input or output.   |
| S2A                    | 15  | I/O                 | Source pin 2 of mux A. Can be an input or output.   |
| VDD                    | 16  | P                   | Positive power supply. This pin is the most positive power-supply potential. For reliable operation, connect a decoupling capacitor ranging from 0.1 $\mu$ F to 10 $\mu$ F between V <sub>DD</sub> and GND. |
| Thermal pad            |     | —                   | Exposed thermal pad with conductive die attached. No requirement to solder this pad. If connected, then it should be left floating or tied to GND.  |

(1) I = input, O = output, I/O = input and output, P = power.

(2) For what to do with unused pins, refer to [Section 8.4](#).

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1) (2) (3)</sup>

|   |   | MIN  | MAX                  | UNIT |
|---|---|------|----------------------|------|
| V <sub>DD</sub>                         | Supply voltage  | -0.5 | 6                    | V    |
| V <sub>SEL</sub> or V <sub>EN</sub>     | Logic control input pin voltage ( $\overline{EN}$ , A0, A1, A2) | -0.5 | 6                    |      |
| V <sub>S</sub> or V <sub>D</sub>        | Source or drain voltage (Sx, D)                                 | -0.5 | V <sub>DD</sub> +1.0 |      |
| I <sub>SEL</sub> or I <sub>EN</sub>     | Logic control input pin current ( $\overline{EN}$ , A0, A1, A2) | -30  | 30                   | mA   |
| I <sub>S</sub> or I <sub>D (CONT)</sub> | Continuous current through switch (Sx, D pins) -40°C to +85°C   | -50  | 50                   |      |
| I <sub>S</sub> or I <sub>D (CONT)</sub> | Continuous current through switch (Sx, D pins) -40°C to +125°C  | -25  | 25                   |      |
| I <sub>GND</sub>                        | Continuous current through GND                                  | -100 | 100                  |      |
| P <sub>tot</sub>                        | Total power dissipation <sup>(4)</sup>                          |      | 500                  | mW   |
| T <sub>stg</sub>                        | Storage temperature   | -65  | 150                  | °C   |
| T <sub>J</sub>                          | Junction temperature  |      | 150                  |      |

- (1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If briefly operating outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum.
- (3) All voltages are with respect to ground, unless otherwise specified.
- (4) For TSSOP package: P<sub>tot</sub> derates linearly above T<sub>A</sub> = 80°C by 7.2mW/°C.

### 6.2 ESD Ratings

|                    |                         | VALUE  | UNIT  |
|--------------------|-------------------------|--|-------|
| V <sub>(ESD)</sub> | Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>  | ±2000 |
|                    |                         | Charged device model (CDM), per JEDEC specification JESD22-C101 or ANSI/ESDA/JEDEC JS-002, all pins <sup>(2)</sup> | ±750  |

- (1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Thermal Information: TMUX1308A

| THERMAL METRIC <sup>(1)</sup> |  | TMUX1308A  | UNIT |
|-------------------------------|--|------------|------|
|                               |  | PW (TSSOP) |      |
|                               |  | PINS       |      |
| R <sub>θJA</sub>              | Junction-to-ambient thermal resistance       | 139        | °C/W |
| R <sub>θJC(top)</sub>         | Junction-to-case (top) thermal resistance    | 77.2       | °C/W |
| R <sub>θJB</sub>              | Junction-to-board thermal resistance         | 84.2       | °C/W |
| Ψ <sub>JT</sub>               | Junction-to-top characterization parameter   | 26.5       | °C/W |
| Ψ <sub>JB</sub>               | Junction-to-board characterization parameter | 83.8       | °C/W |
| R <sub>θJC(bot)</sub>         | Junction-to-case (bottom) thermal resistance | N/A        | °C/W |

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

### 6.4 Thermal Information: TMUX1309A

| THERMAL METRIC <sup>(1)</sup> |   | TMUX1309A  | UNIT |
|-------------------------------|---|------------|------|
|                               |   | PW (TSSOP) |      |
|                               |   | PINS       |      |
| R <sub>θJA</sub>              | Junction-to-ambient thermal resistance thermal information for TMUX1309 | 139        | °C/W |
| R <sub>θJC(top)</sub>         | Junction-to-case (top) thermal resistance                               | 77.2       | °C/W |
| R <sub>θJB</sub>              | Junction-to-board thermal resistance                                    | 84.2       | °C/W |
| Ψ <sub>JT</sub>               | Junction-to-top characterization parameter                              | 26.5       | °C/W |
| Ψ <sub>JB</sub>               | Junction-to-board characterization parameter                            | 83.8       | °C/W |
| R <sub>θJC(bot)</sub>         | Junction-to-case (bottom) thermal resistance                            | N/A        | °C/W |

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

### 6.5 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|   |  | MIN  | NOM | MAX             | UNIT |
|---|--|------|-----|-----------------|------|
| V <sub>DD</sub>                         | Supply voltage   | 1.62 |     | 5.5             | V    |
| V <sub>S</sub> or V <sub>D</sub>        | Signal path input/output voltage (source or drain pin) (Sx, D)   | 0    |     | V <sub>DD</sub> | V    |
| V <sub>SEL</sub> or V <sub>EN</sub>     | Logic control input pin voltage (EN, A0, A1, A2)   | 0    |     | 5.5             | V    |
| I <sub>S</sub> or I <sub>D (CONT)</sub> | Continuous current through switch (Sx, D pins) –40°C to +85°C  | –50  |     | 50              | mA   |
| I <sub>S</sub> or I <sub>D (CONT)</sub> | Continuous current through switch (Sx, D pins) –40°C to +125°C   | –25  |     | 25              | mA   |
| I <sub>OK</sub>                         | Current per input into source or drain pins when signal voltage exceeds recommended operating voltage <sup>(1)</sup> | –50  |     | 50              | mA   |
| I <sub>INJ</sub>                        | Injected current into single off switch input  | –50  |     | 50              | mA   |
| I <sub>INJ_ALL</sub>                    | Total injected current into all off switch inputs combined   | –100 |     | 100             | mA   |
| T <sub>A</sub>                          | Ambient temperature  | –40  |     | 125             | °C   |

(1) If source or drain voltage exceeds V<sub>DD</sub>, or goes below GND, the pin will be shunted to GND through an internal FET, the current must be limited within the specified value. If V<sub>signal</sub> > V<sub>DD</sub> or if V<sub>signal</sub> < GND.

## 6.6 Electrical Characteristics

At specified  $V_{DD} \pm 10\%$

Typical values measured at nominal  $V_{DD}$

| PARAMETER                  | TEST CONDITIONS                                    | $V_{DD}$   | Operating free-air temperature ( $T_A$ ) |         |      |               |     |      |                |     |      | UNIT     |
|----------------------------|--|--|--|---------|------|---------------|-----|------|----------------|-----|------|----------|
|                            |  |  | 25°C                                     |         |      | –40°C to 85°C |     |      | –40°C to 125°C |     |      |          |
|                            |  |  | MIN                                      | TYP     | MAX  | MIN           | TYP | MAX  | MIN            | TYP | MAX  |          |
| ANALOG SWITCH              |  |  |  |         |      |               |     |      |                |     |      |          |
| $R_{ON}$                   | On-state switch resistance                         | $V_S = 0V$ to $V_{DD}$<br>$I_{SD} = 0.5mA$   | 1.8V                                     | 650     | 1500 |               |     | 1700 |                |     | 1700 | $\Omega$ |
|                            |  |  | 2.5V                                     | 230     | 600  |               |     | 670  |                |     | 670  |          |
|                            |  |  | 3.3V                                     | 120     | 330  |               |     | 350  |                |     | 370  |          |
|                            |  |  | 5V                                       | 75      | 195  |               |     | 220  |                |     | 270  |          |
| $\Delta_{RON}$             | On-state switch resistance matching between inputs | $V_S = V_{DD} / 2$<br>$I_{SD} = 0.5mA$   | 1.8V                                     | 10      | 38   |               |     | 45   |                |     | 45   | $\Omega$ |
|                            |  |  | 2.5V                                     | 3       | 20   |               |     | 22   |                |     | 22   |          |
|                            |  |  | 3.3V                                     | 2       | 8    |               |     | 11   |                |     | 15   |          |
|                            |  |  | 5V                                       | 1       | 7    |               |     | 10   |                |     | 14   |          |
| $I_{S(OFF)}$               | Source off-state leakage current                   | Switch Off<br>$V_D = 0.8 \times V_{DD} / 0.2 \times V_{DD}$<br>$V_S = 0.2 \times V_{DD} / 0.8 \times V_{DD}$ | 1.8V                                     | $\pm 1$ |      | –25           |     | 25   | –800           |     | 800  | nA       |
|                            |  |  | 2.5V                                     | $\pm 1$ |      | –25           |     | 25   | –800           |     | 800  |          |
|                            |  |  | 3.3V                                     | $\pm 1$ |      | –25           |     | 25   | –800           |     | 800  |          |
|                            |  |  | 5V                                       | $\pm 1$ |      | –25           |     | 25   | –800           |     | 800  |          |
| $I_{D(OFF)}$               | Drain off-state leakage current (common drain pin) | Switch Off<br>$V_D = 0.8 \times V_{DD} / 0.2 \times V_{DD}$<br>$V_S = 0.2 \times V_{DD} / 0.8 \times V_{DD}$ | 1.8V                                     | $\pm 1$ |      | –45           |     | 45   | –800           |     | 800  | nA       |
|                            |  |  | 2.5V                                     | $\pm 1$ |      | –45           |     | 45   | –800           |     | 800  |          |
|                            |  |  | 3.3V                                     | $\pm 1$ |      | –45           |     | 45   | –800           |     | 800  |          |
|                            |  |  | 5V                                       | $\pm 1$ |      | –45           |     | 45   | –800           |     | 800  |          |
| $I_{D(ON)}$<br>$I_{S(ON)}$ | Channel on-state leakage current                   | Switch On<br>$V_D = V_S = 0.8 \times V_{DD}$ or<br>$V_D = V_S = 0.2 \times V_{DD}$                           | 1.8V                                     | $\pm 1$ |      | –45           |     | 45   | –800           |     | 800  | nA       |
|                            |  |  | 2.5V                                     | $\pm 1$ |      | –45           |     | 45   | –800           |     | 800  |          |
|                            |  |  | 3.3V                                     | $\pm 1$ |      | –45           |     | 45   | –800           |     | 800  |          |
|                            |  |  | 5V                                       | $\pm 1$ |      | –45           |     | 45   | –800           |     | 800  |          |
| $C_{SOFF}$                 | Source off capacitance                             | $V_S = V_{DD} / 2$<br>$f = 1MHz$   | 1.8V                                     | 2       | 14   |               |     | 14   |                |     | 14   | pF       |
|                            |  |  | 2.5V                                     | 2       | 14   |               |     | 14   |                |     | 14   |          |
|                            |  |  | 3.3V                                     | 2       | 14   |               |     | 14   |                |     | 14   |          |
|                            |  |  | 5V                                       | 2       | 14   |               |     | 14   |                |     | 14   |          |
| $C_{DOFF}$                 | Drain off capacitance                              | $V_S = V_{DD} / 2$<br>$f = 1MHz$   | 1.8V                                     | 7       | 37   |               |     | 37   |                |     | 37   | pF       |
|                            |  |  | 2.5V                                     | 7       | 37   |               |     | 37   |                |     | 37   |          |
|                            |  |  | 3.3V                                     | 7       | 37   |               |     | 37   |                |     | 37   |          |
|                            |  |  | 5V                                       | 7       | 37   |               |     | 37   |                |     | 37   |          |
| $C_{SON}$<br>$C_{DON}$     | On capacitance                                     | $V_S = V_{DD} / 2$<br>$f = 1MHz$   | 1.8V                                     | 11      | 40   |               |     | 40   |                |     | 40   | pF       |
|                            |  |  | 2.5V                                     | 11      | 40   |               |     | 40   |                |     | 40   |          |
|                            |  |  | 3.3V                                     | 11      | 40   |               |     | 40   |                |     | 40   |          |
|                            |  |  | 5V                                       | 11      | 40   |               |     | 40   |                |     | 40   |          |
| POWER SUPPLY               |  |  |  |         |      |               |     |      |                |     |      |          |
| $I_{DD}$                   | $V_{DD}$ supply current                            | Logic inputs = 0V or $V_{DD}$  | 1.8V                                     |         | 1    |               |     | 1    |                |     | 1.2  | $\mu A$  |
|                            |  |  | 2.5V                                     |         | 1    |               |     | 1    |                |     | 1.5  |          |
|                            |  |  | 3.3V                                     |         | 1    |               |     | 1    |                |     | 2    |          |
|                            |  |  | 5V                                       |         | 1    |               |     | 1.5  |                |     | 3    |          |



## 6.7 Logic and Dynamic Characteristics

At specified  $V_{DD} \pm 10\%$

Typical values measured at nominal  $V_{DD}$  and  $T_A = 25^\circ\text{C}$ .

| PARAMETER                                    | TEST CONDITIONS                  | $V_{DD}$   | Operating free-air temperature ( $T_A$ ) |      |     | UNIT |    |
|--|----------------------------------|--|--|------|-----|------|----|
|  |                                  |  | –40°C to 125°C                           |      |     |      |    |
|  |                                  |  | MIN                                      | TYP  | MAX |      |    |
| LOGIC INPUTS ( $\overline{E}N$ , A0, A1, A2) |                                  |  |  |      |     |      |    |
| $V_{IH}$                                     | Input logic high                 | 1.8V   | 0.95                                     | 5.5  | V   |      |    |
|  |                                  | 2.5V   | 1.1                                      | 5.5  |     |      |    |
|  |                                  | 3.3V   | 1.15                                     | 5.5  |     |      |    |
|  |                                  | 5V   | 1.25                                     | 5.5  |     |      |    |
| $V_{IL}$                                     | Input logic low                  | 1.8V   | 0  | 0.6  | V   |      |    |
|  |                                  | 2.5V   | 0  | 0.7  |     |      |    |
|  |                                  | 3.3V   | 0  | 0.8  |     |      |    |
|  |                                  | 5V   | 0  | 0.95 |     |      |    |
| $I_{IH}$                                     | Logic high input leakage current | $V_{LOGIC} = 1.8\text{V or }V_{DD}$  | All                                      |      | 1   | uA   |    |
| $I_{IL}$                                     | Logic low input leakage current  | $V_{LOGIC} = 0\text{V}$  | All                                      | –1   |     | uA   |    |
| $C_{IN}$                                     | Logic input capacitance          | $V_{LOGIC} = 0\text{V, }1.8\text{V, }V_{DD}$<br>$f = 1\text{MHz}$  | All                                      |      | 1   | 2    | pF |
| DYNAMIC CHARACTERISTICS                      |                                  |  |  |      |     |      |    |
| $Q_{INJ}$                                    | Charge Injection                 | $V_S = V_{DD} / 2$<br>$R_S = 0\Omega, C_L = 100\text{pF}$  | 1.8V                                     | –0.5 | pC  |      |    |
|  |                                  |  | 2.5V                                     | –0.5 |     |      |    |
|  |                                  |  | 3.3V                                     | –0.8 |     |      |    |
|  |                                  |  | 5V                                       | –1.5 |     |      |    |
| $O_{ISO}$                                    | Off Isolation                    | $V_{BIAS} = V_{DD} / 2$<br>$V_S = 200\text{mVpp}$<br>$R_L = 50\Omega, C_L = 5\text{pF}$<br>$f = 100\text{kHz}$ | 1.8V                                     | –110 | dB  |      |    |
|  |                                  |  | 2.5V                                     | –110 |     |      |    |
|  |                                  |  | 3.3V                                     | –110 |     |      |    |
|  |                                  |  | 5V                                       | –110 |     |      |    |
| $O_{ISO}$                                    | Off Isolation                    | $V_{BIAS} = V_{DD} / 2$<br>$V_S = 200\text{mVpp}$<br>$R_L = 50\Omega, C_L = 5\text{pF}$<br>$f = 1\text{MHz}$   | 1.8V                                     | –90  | dB  |      |    |
|  |                                  |  | 2.5V                                     | –90  |     |      |    |
|  |                                  |  | 3.3V                                     | –90  |     |      |    |
|  |                                  |  | 5V                                       | –90  |     |      |    |
| $X_{TALK}$                                   | Crosstalk                        | $V_{BIAS} = V_{DD} / 2$<br>$V_S = 200\text{mVpp}$<br>$R_L = 50\Omega, C_L = 5\text{pF}$<br>$f = 100\text{kHz}$ | 1.8V                                     | –110 | dB  |      |    |
|  |                                  |  | 2.5V                                     | –110 |     |      |    |
|  |                                  |  | 3.3V                                     | –110 |     |      |    |
|  |                                  |  | 5V                                       | –110 |     |      |    |
| $X_{TALK}$                                   | Crosstalk                        | $V_{BIAS} = V_{DD} / 2$<br>$V_S = 200\text{mVpp}$<br>$R_L = 50\Omega, C_L = 5\text{pF}$<br>$f = 1\text{MHz}$   | 1.8V                                     | –90  | dB  |      |    |
|  |                                  |  | 2.5V                                     | –90  |     |      |    |
|  |                                  |  | 3.3V                                     | –90  |     |      |    |
|  |                                  |  | 5V                                       | –90  |     |      |    |
| BW   | Bandwidth                        | $V_{BIAS} = V_{DD} / 2$<br>$V_S = 200\text{mVpp}$<br>$R_L = 50\Omega, C_L = 5\text{pF}$                        | 1.8V                                     | 350  | MHz |      |    |
|  |                                  |  | 2.5V                                     | 450  |     |      |    |
|  |                                  |  | 3.3V                                     | 500  |     |      |    |
|  |                                  |  | 5V                                       | 500  |     |      |    |

## 6.8 Timing Characteristics

At specified  $V_{DD} \pm 10\%$

Typical values measured at nominal  $V_{DD}$ .

| PARAMETER                 | TEST CONDITIONS                   | $V_{DD}$   | Operating free-air temperature ( $T_A$ ) |     |     |               |     |     |                |     |     | UNIT |
|---------------------------|-----------------------------------|--|--|-----|-----|---------------|-----|-----|----------------|-----|-----|------|
|                           |                                   |  | 25°C                                     |     |     | -40°C to 85°C |     |     | -40°C to 125°C |     |     |      |
|                           |                                   |  | MIN                                      | TYP | MAX | MIN           | TYP | MAX | MIN            | TYP | MAX |      |
| SWITCHING CHARACTERISTICS |                                   |  |  |     |     |               |     |     |                |     |     |      |
| $t_{PD}$                  | Propagation delay                 | $C_L = 50\text{pF}$<br>Sx to D, D to Sx                          | 1.8V                                     | 15  | 30  |               |     | 30  |                |     | 30  | ns   |
|                           |                                   |  | 2.5V                                     | 8   | 15  |               |     | 20  |                |     | 20  |      |
|                           |                                   |  | 3.3V                                     | 5   | 11  |               |     | 15  |                |     | 15  |      |
|                           |                                   |  | 5V                                       | 4   | 9   |               |     | 10  |                |     | 10  |      |
|                           |                                   | 5V   | 1.5                                      | 4   |     |               | 5   |     |                | 5   |     |      |
| $t_{TRAN}$                | Transition-time<br>between inputs | $R_L = 10\text{k}\Omega, C_L = 50\text{pF}$<br>Ax to D, Ax to Sx | 1.8V                                     | 44  | 94  |               |     | 103 |                |     | 103 | ns   |
|                           |                                   |  | 2.5V                                     | 30  | 63  |               |     | 67  |                |     | 67  |      |
|                           |                                   |  | 3.3V                                     | 23  | 51  |               |     | 54  |                |     | 54  |      |
|                           |                                   |  | 5V                                       | 18  | 43  |               |     | 46  |                |     | 46  |      |
|                           |                                   | 5V   | 15                                       | 39  |     |               | 43  |     |                | 43  |     |      |
| $t_{ON(EN)}$              | Turnon-time from<br>enable        | $R_L = 10\text{k}\Omega, C_L = 50\text{pF}$<br>EN to D, EN to Sx | 1.8V                                     | 39  | 68  |               |     | 75  |                |     | 75  | ns   |
|                           |                                   |  | 2.5V                                     | 30  | 48  |               |     | 50  |                |     | 50  |      |
|                           |                                   |  | 3.3V                                     | 26  | 40  |               |     | 42  |                |     | 42  |      |
|                           |                                   |  | 5V                                       | 24  | 34  |               |     | 37  |                |     | 37  |      |
|                           |                                   | 5V   | 22                                       | 31  |     |               | 35  |     |                | 35  |     |      |
| $t_{OFF(EN)}$             | Turnoff time from<br>enable       | $R_L = 10\text{k}\Omega, C_L = 50\text{pF}$<br>EN to D, EN to Sx | 1.8V                                     | 60  | 80  |               |     | 85  |                |     | 85  | ns   |
|                           |                                   |  | 2.5V                                     | 50  | 70  |               |     | 72  |                |     | 72  |      |
|                           |                                   |  | 3.3V                                     | 40  | 65  |               |     | 70  |                |     | 70  |      |
|                           |                                   |  | 5V                                       | 28  | 50  |               |     | 55  |                |     | 55  |      |
|                           |                                   | 5V   | 23                                       | 30  |     |               | 35  |     |                | 35  |     |      |
| $t_{BBM}$                 | Break before make<br>time         | $R_L = 10\text{k}\Omega, C_L = 15\text{pF}$<br>Sx to D, D to Sx  | 1.8V                                     | 1   | 16  |               | 1   |     | 1              |     | ns  |      |
|                           |                                   |  | 2.5V                                     | 1   | 22  |               | 1   |     | 1              |     |     |      |
|                           |                                   |  | 3.3V                                     | 1   | 24  |               | 1   |     | 1              |     |     |      |
|                           |                                   |  | 5V                                       | 1   | 33  |               | 1   |     | 1              |     |     |      |

## 6.9 Injection Current Coupling

At specified  $V_{DD} \pm 10\%$

Typical values measured at nominal  $V_{DD}$  and  $T_A = 25^\circ\text{C}$ .

| PARAMETER                         | $V_{DD}$  | TEST CONDITIONS |                              | -40°C to 125°C             |      |     | UNIT |
|-----------------------------------|---|-----------------|------------------------------|----------------------------|------|-----|------|
|                                   |   |                 |                              | MIN                        | TYP  | MAX |      |
| <b>INJECTION CURRENT COUPLING</b> |   |                 |                              |                            |      |     |      |
| $\Delta V_{OUT}$                  | Maximum shift of output voltage of enabled analog input | 1.8V            | $R_S \leq 3.9\text{k}\Omega$ | $I_{INJ} \leq 1\text{mA}$  | 0.01 | 1   | mV   |
|                                   |   | 3.3V            |                              |                            | 0.05 | 1   |      |
|                                   |   | 5V              |                              |                            | 0.1  | 1   |      |
|                                   |   | 1.8V            | $R_S \leq 3.9\text{k}\Omega$ | $I_{INJ} \leq 10\text{mA}$ | 0.01 | 2   |      |
|                                   |   | 3.3V            |                              |                            | 0.3  | 3   |      |
|                                   |   | 5V              |                              |                            | 0.06 | 4   |      |
|                                   |   | 1.8V            | $R_S \leq 20\text{k}\Omega$  | $I_{INJ} \leq 1\text{mA}$  | 0.05 | 2   |      |
|                                   |   | 3.3V            |                              |                            | 0.05 | 2   |      |
|                                   |   | 5V              |                              |                            | 0.1  | 2   |      |
|                                   |   | 1.8V            | $R_S \leq 20\text{k}\Omega$  | $I_{INJ} \leq 10\text{mA}$ | 0.05 | 15  |      |
|                                   |   | 3.3V            |                              |                            | 0.05 | 15  |      |
|                                   |   | 5V              |                              |                            | 0.02 | 15  |      |

## 6.10 Typical Characteristics

at  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 5\text{V}$  (unless otherwise noted)

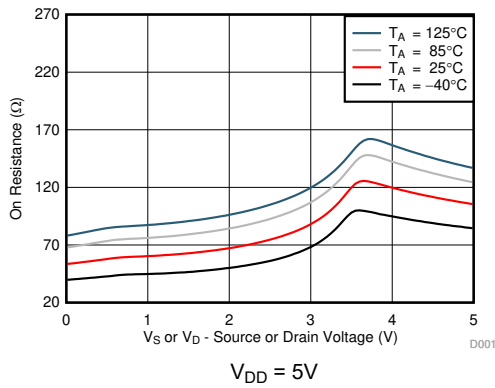


Figure 6-1. On-Resistance vs Temperature

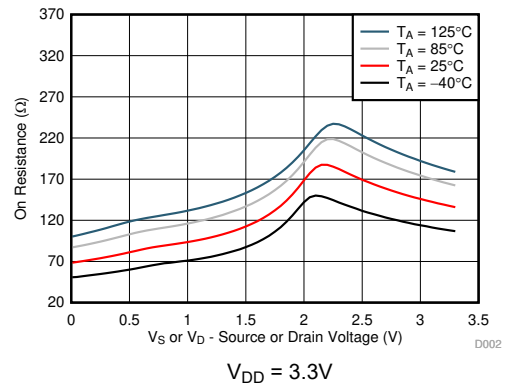


Figure 6-2. On-Resistance vs Temperature

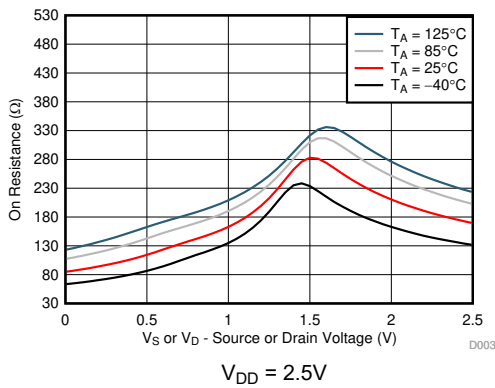


Figure 6-3. On-Resistance vs Temperature

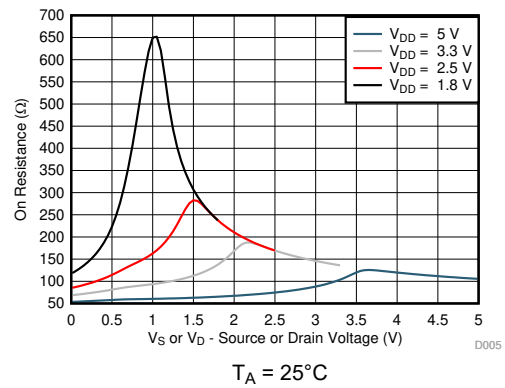


Figure 6-4. On-Resistance vs Source or Drain Voltage

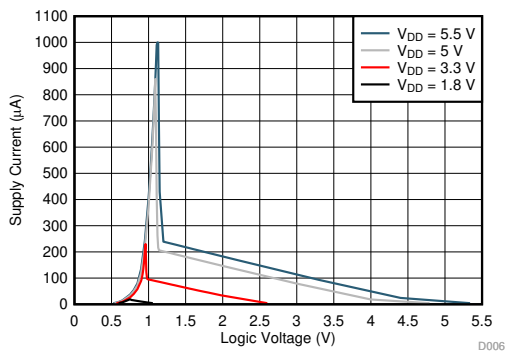


Figure 6-5. Supply Current vs Logic Voltage

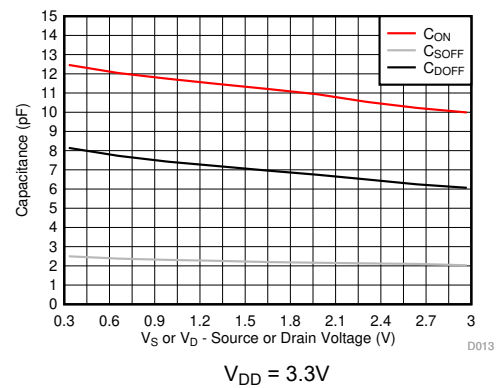
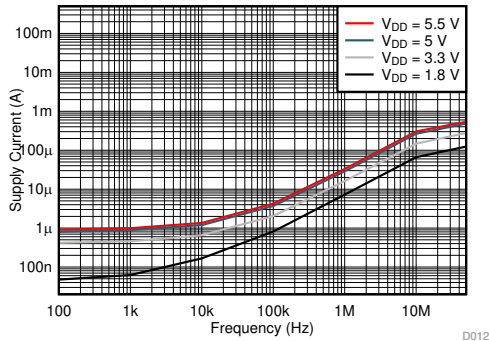


Figure 6-6. Capacitance vs Source Voltage

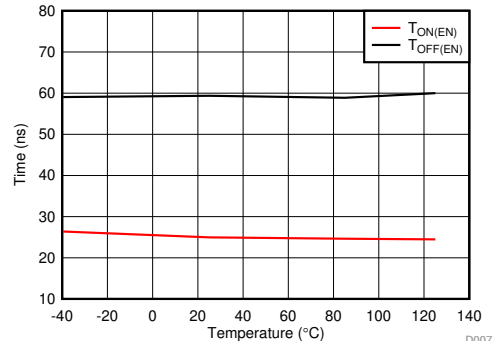
### 6.10 Typical Characteristics (continued)

at  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 5\text{V}$  (unless otherwise noted)



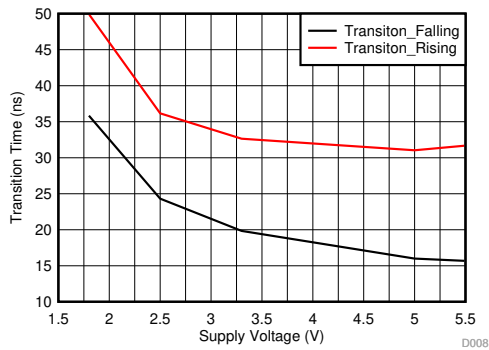
$T_A = 25^\circ\text{C}$

**Figure 6-7. Supply Current vs Input Switching Frequency**



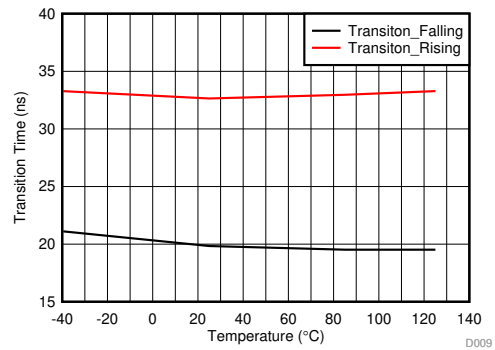
$V_{DD} = 3.3\text{V}$

**Figure 6-8.  $T_{ON(EN)}$  and  $T_{OFF(EN)}$  vs Temperature**



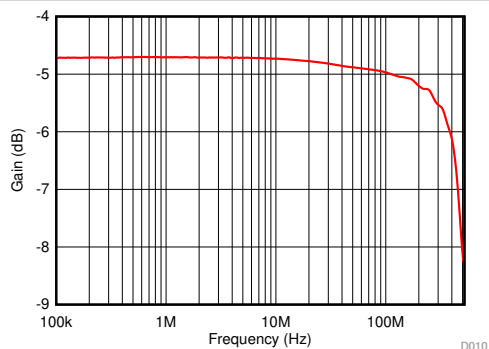
$T_A = 25^\circ\text{C}$

**Figure 6-9.  $T_{TRANSITION}$  vs Supply Voltage**



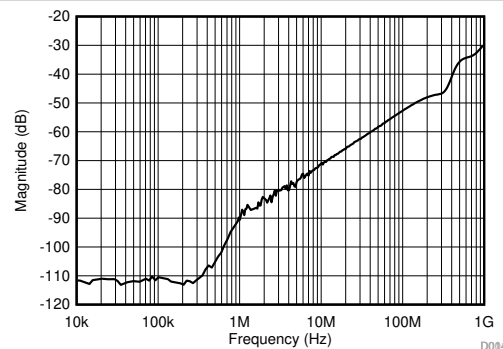
$T_A = 25^\circ\text{C}$

**Figure 6-10.  $T_{TRANSITION}$  vs Temperature**



$T_A = 25^\circ\text{C}$

**Figure 6-11. On Response vs Frequency**

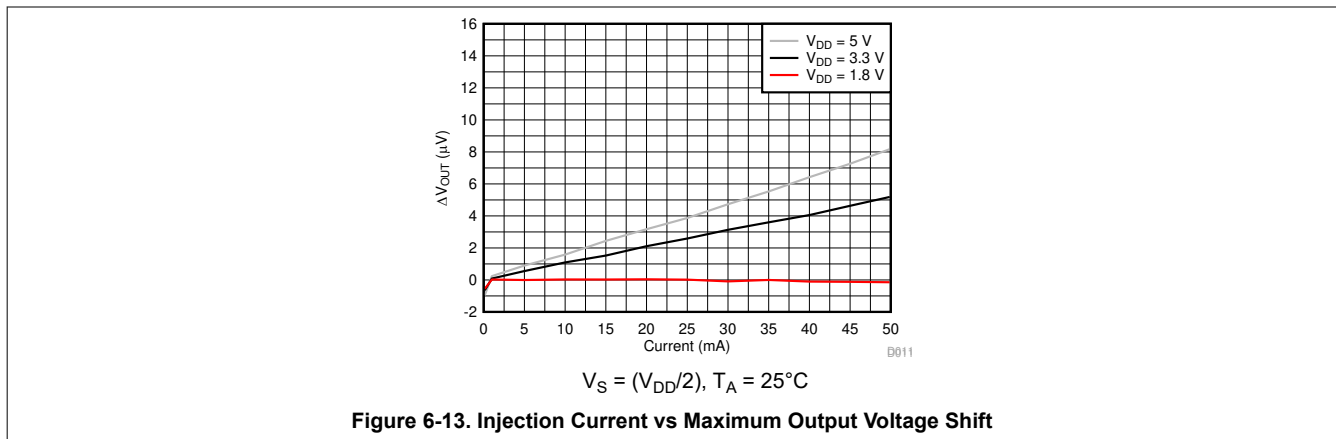


$T_A = 25^\circ\text{C}$ ,  $V_{DD} = 3.3\text{V}$

**Figure 6-12. Xtalk and Off-Isolation vs Frequency**

## 6.10 Typical Characteristics (continued)

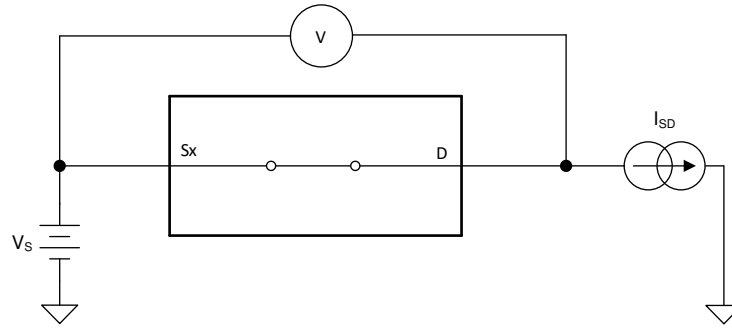
at  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 5\text{V}$  (unless otherwise noted)



## 7 Parameter Measurement Information

### 7.1 On-Resistance

The on-resistance of a device is the ohmic resistance between the source (Sx) and drain (D) pins of the device. The on-resistance varies with input voltage and supply voltage. The symbol  $R_{ON}$  is used to denote on-resistance. The measurement setup used to measure  $R_{ON}$  is shown in the following figure. Voltage (V) and current ( $I_{SD}$ ) are measured using this setup, and  $R_{ON}$  is computed as shown in Figure 7-1 with  $R_{ON} = V / I_{SD}$ :



**Figure 7-1. On-Resistance Measurement Setup**

### 7.2 Off-Leakage Current

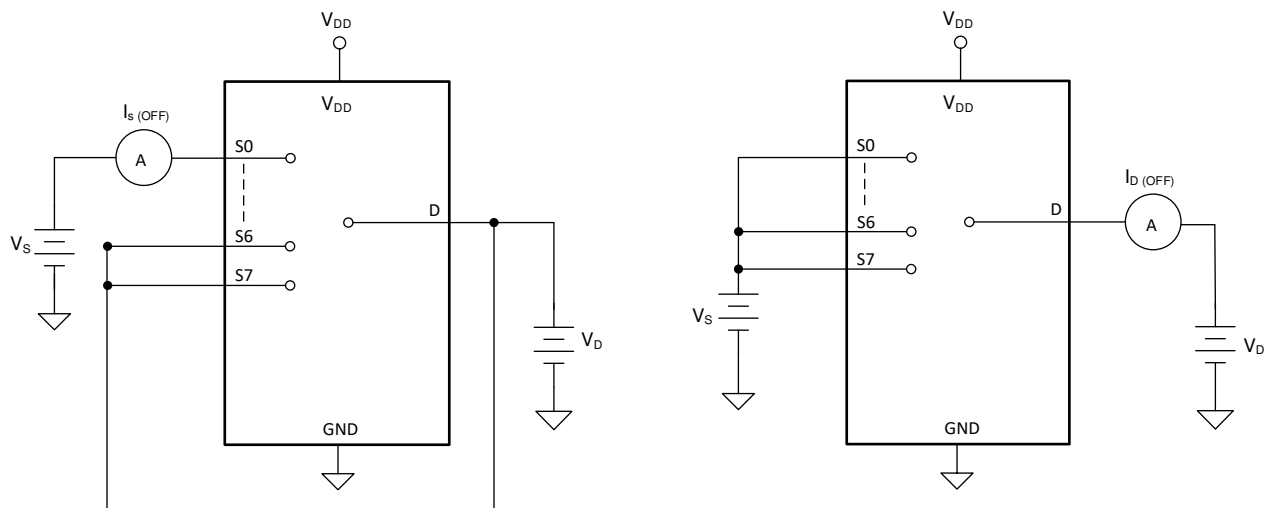
There are two types of leakage currents associated with a switch during the off state:

1. Source off-leakage current.
2. Drain off-leakage current.

Source leakage current is defined as the leakage current flowing into or out of the source pin when the switch is off. This current is denoted by the symbol  $I_{S(OFF)}$ .

Drain leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is off. This current is denoted by the symbol  $I_{D(OFF)}$ .

Figure 7-2 shows the setup used to measure both off-leakage currents.



**Figure 7-2. Off-Leakage Measurement Setup**

### 7.3 On-Leakage Current

Source on-leakage current is defined as the leakage current flowing into or out of the source pin when the switch is on. This current is denoted by the symbol  $I_{S(ON)}$ .

Drain on-leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is on. This current is denoted by the symbol  $I_{D(ON)}$ .

Either the source pin or drain pin is left floating during the measurement. Figure 7-3 shows the circuit used for measuring the on-leakage current, denoted by  $I_{S(ON)}$  or  $I_{D(ON)}$ .

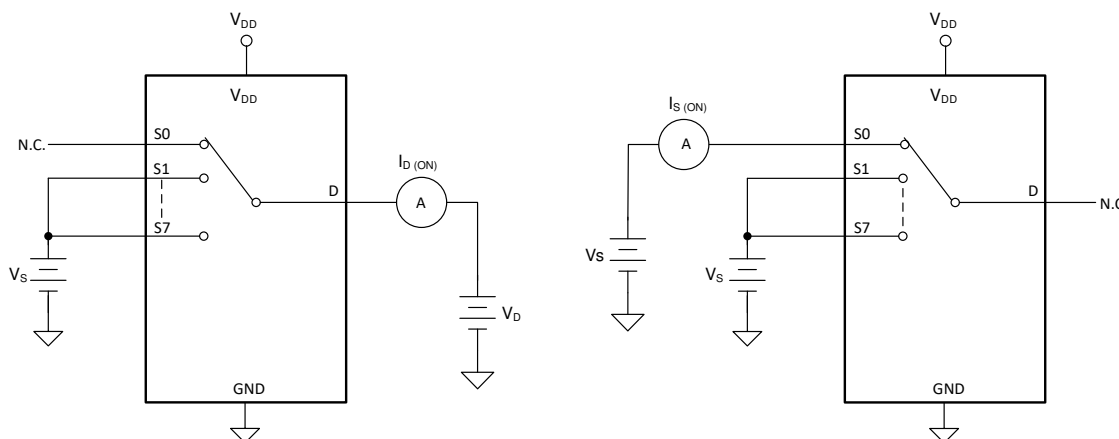


Figure 7-3. On-Leakage Measurement Setup

### 7.4 Transition Time

Transition time is defined as the time taken by the output of the device to rise or fall 50% after the address signal has risen or fallen past the 50% threshold. Figure 7-4 shows the setup used to measure transition time, denoted by the symbol  $t_{TRANSITION}$ .

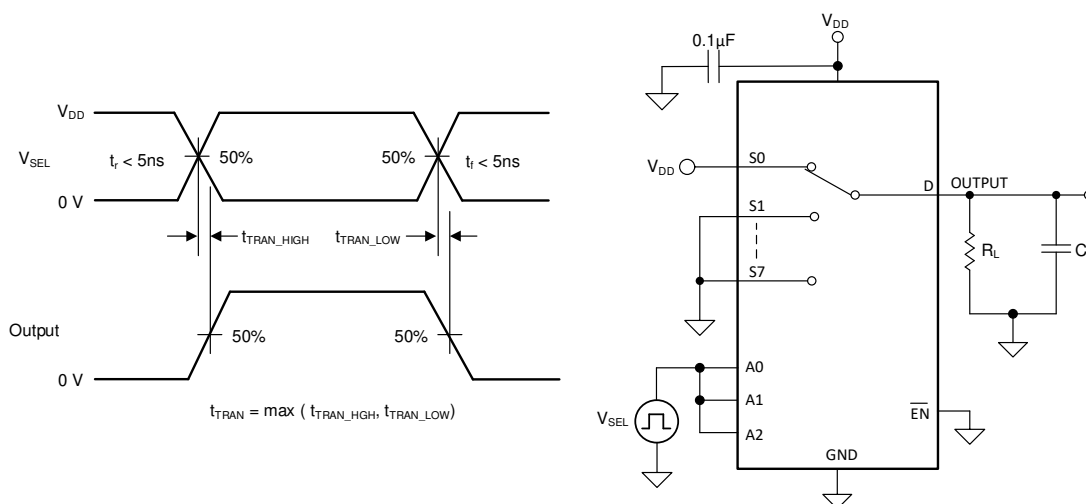


Figure 7-4. Transition-Time Measurement Setup



## 7.5 Break-Before-Make

Break-before-make delay is a safety feature that prevents two inputs from connecting when the device is switching. The output first breaks from the on-state switch before making the connection with the next on-state switch. The time delay between the *break* and the *make* is known as break-before-make delay. Figure 7-5 shows the setup used to measure break-before-make delay, denoted by the symbol  $t_{\text{OPEN(BBM)}}$ .

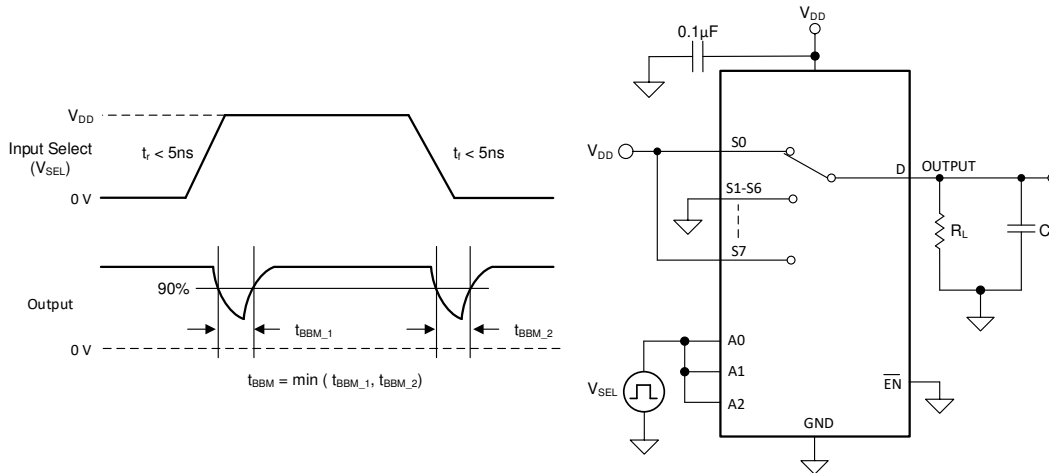


Figure 7-5. Break-Before-Make Delay Measurement Setup

## 7.6 $t_{\text{ON(EN)}}$ and $t_{\text{OFF(EN)}}$

Turn-on time is defined as the time taken by the output of the device to rise to 10% after the enable has risen past the 50% threshold. The 10% measurement is utilized to provide the timing of the device, system level timing can then account for the time constant added from the load resistance and load capacitance. Figure 7-6 shows the setup used to measure transition time, denoted by the symbol  $t_{\text{ON(EN)}}$ .

Turn-off time is defined as the time taken by the output of the device to fall to 90% after the enable has fallen past the 50% threshold. The 90% measurement is utilized to provide the timing of the device, system level timing can then account for the time constant added from the load resistance and load capacitance. Figure 7-6 shows the setup used to measure transition time, denoted by the symbol  $t_{\text{OFF(EN)}}$ .

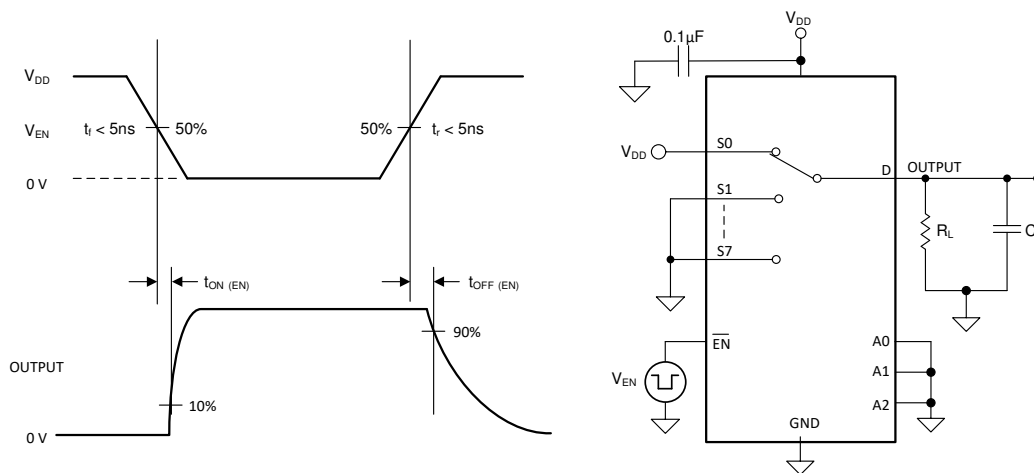


Figure 7-6. Turn-On and Turn-Off Time Measurement Setup

## 7.7 Charge Injection

The TMUX1308A and TMUX1309A device have a transmission-gate topology. Any mismatch in capacitance between the NMOS and PMOS transistors results in a charge injected into the drain or source during the falling or rising edge of the gate signal. The amount of charge injected into the source or drain of the device is known as charge injection, and is denoted by the symbol  $Q_C$ . Figure 7-7 shows the setup used to measure charge injection from source (Sx) to drain (D).

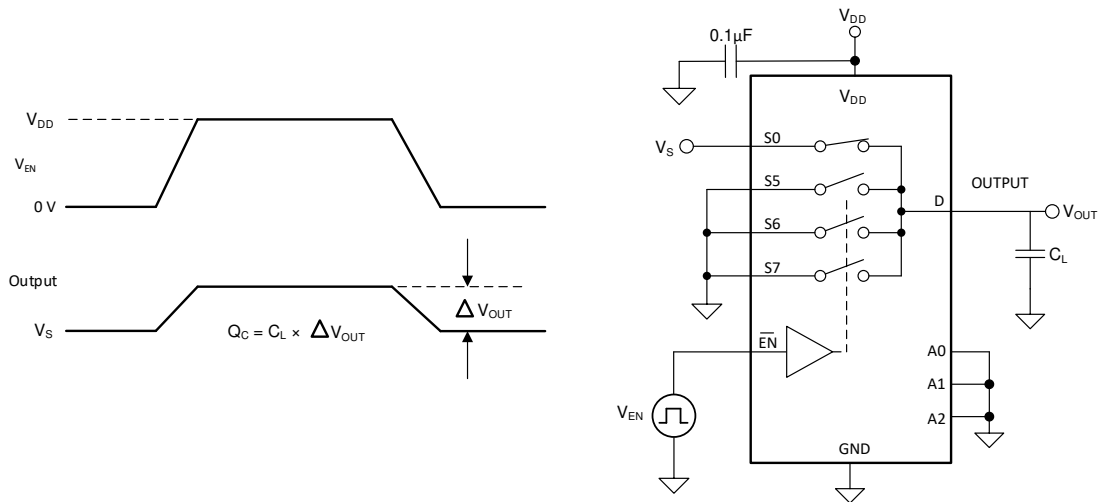


Figure 7-7. Charge-Injection Measurement Setup

## 7.8 Off Isolation

Off isolation is defined as the ratio of the signal at the drain pin (D) of the device when a signal is applied to the source pin (Sx) of an off-channel. Figure 7-8 shows the setup used to measure, and the equation to compute off isolation.

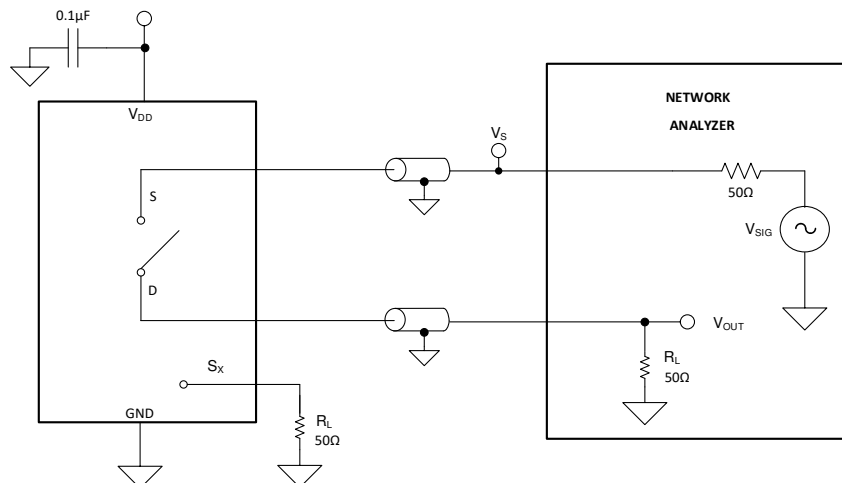
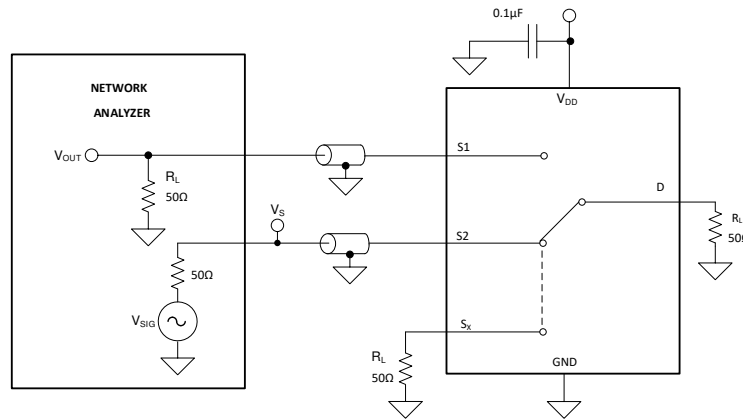


Figure 7-8. Off Isolation Measurement Setup

$$\text{Off Isolation} = 20 \times \text{Log} \left( \frac{V_{OUT}}{V_S} \right) \quad (1)$$

## 7.9 Crosstalk

Crosstalk is defined as the ratio of the signal at the drain pin (D) of a different channel, when a signal is applied at the source pin (Sx) of an on-channel. [Figure 7-9](#) shows the setup used to measure, and the equation used to compute crosstalk.

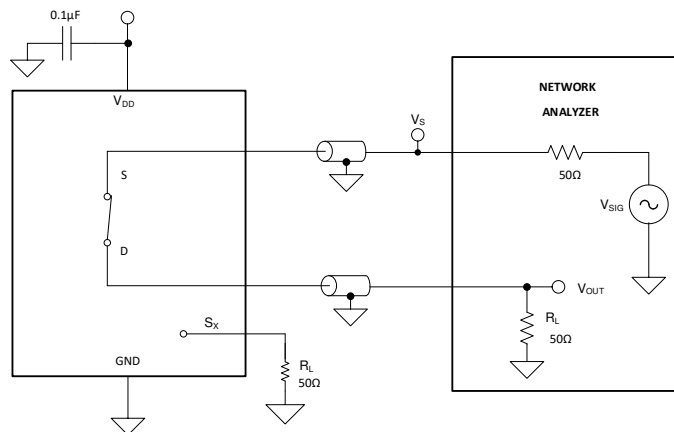


**Figure 7-9. Channel-to-Channel Crosstalk Measurement Setup**

$$\text{Channel-to-Channel Crosstalk} = 20 \times \text{Log} \left( \frac{V_{OUT}}{V_S} \right) \quad (2)$$

## 7.10 Bandwidth

Bandwidth is defined as the range of frequencies that are attenuated by less than 3 dB when the input is applied to the source pin (Sx) of an on-channel, and the output is measured at the drain pin (D) of the device. [Figure 7-10](#) shows the setup used to measure bandwidth.



**Figure 7-10. Bandwidth Measurement Setup**

$$\text{Attenuation} = 20 \times \text{Log} \left( \frac{V_2}{V_1} \right) \quad (3)$$

## 7.11 Injection Current Control

Injection current is measured at the change in output of the enabled signal path when a current is injected into a disabled signal path. Figure 7-11 shows the setup used to measure injection current control.

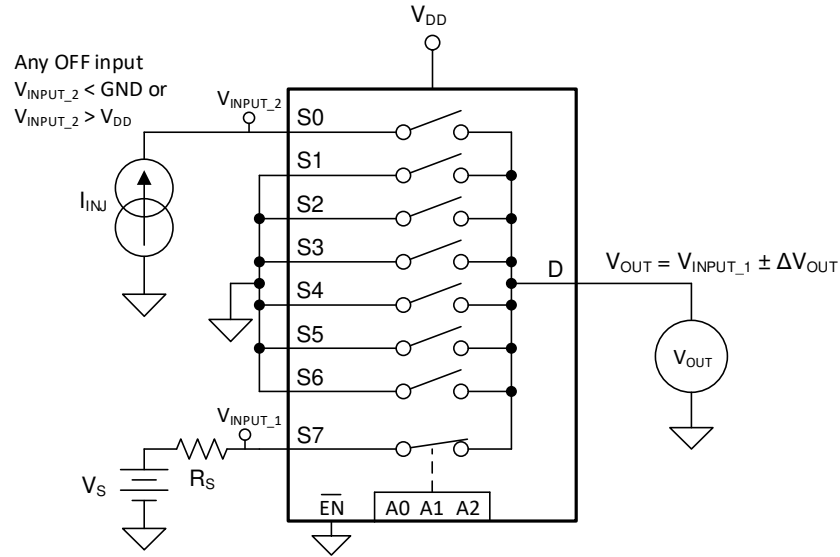


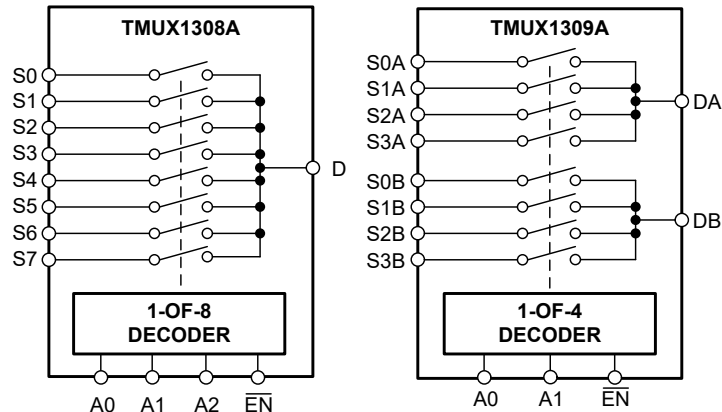
Figure 7-11. Injection Current Measurement Setup

## 8 Detailed Description

### 8.1 Overview

The TMUX1308A is an 8:1, single-ended (1-channel), mux. The TMUX1309A is a 4:1, differential (2-channel) mux. Each channel is turned on or turned off based on the state of the address lines and enable pin.

### 8.2 Functional Block Diagram



### 8.3 Feature Description

#### 8.3.1 Bidirectional Operation

The TMUX1308A and TMUX1309A devices conduct equally well from source ( $S_x$ ) to drain ( $D_x$ ) or from drain ( $D_x$ ) to source ( $S_x$ ). Each signal path has very similar characteristics in both directions so they can be used as both multiplexers and demultiplexer to support both analog and digital signals.

#### 8.3.2 Rail-to-Rail Operation

The valid signal path input and output voltage for the TMUX1308A and TMUX1309A ranges from GND to  $V_{DD}$ .

#### 8.3.3 1.8V Logic Compatible Inputs

The TMUX1308A and TMUX1309A support 1.8V logic compatible control for all logic control inputs. The logic input thresholds scale with supply but still provide 1.8V logic control when operating at 5.5V supply voltage. 1.8V logic level inputs allows the multiplexers to interface with processors that have lower logic I/O rails and eliminates the need for an external voltage translator, which saves both space and BOM cost. The current consumption of the TMUX1308A and TMUX1309A devices increase when using 1.8V logic with higher supply voltage. For more information on 1.8V logic implementations, refer to [Simplifying Design with 1.8V logic Muxes and Switches](#).

#### 8.3.4 Fail-Safe Logic

The TMUX1308A and TMUX1309A device have Fail-Safe Logic on the control input pins (EN, A0, A1, and A2) allowing for operation up to 5.5V, regardless of the state of the supply pin. This feature allows voltages on the control pins to be applied before the supply pin, protecting the device from potential damage. Fail-Safe Logic minimizes system complexity by removing the need for power supply sequencing on the logic control pins. For example, the Fail-Safe Logic feature allows the select pins of the TMUX1308A and TMUX1309A to be ramped to 5.5V while  $V_{DD} = 0V$ . Additionally, the feature enables operation of the multiplexers with  $V_{DD} = 1.8V$  while allowing the select pins to interface with a logic level of another device up to 5.5V, eliminating the potential need for an external voltage translator.

### 8.3.5 High-Impedance Optimization

TMUX1308A and TMUX1309A are optimized for high-impedance loads. When a switch input is connected to a high-impedance output the RC on the input side can cause the output to settle slower. Reducing this RC is one way to make the settling time quicker. Multiplexers can also have an impact on how long it takes for the output to settle through charge injection. When the switch is turning ON, a higher charge injection can cause the source to be pulled away from the desired settling voltage. This means that the output will need to rise or fall further than anticipated causing additional settling time. In the following figure, a specific load condition is tested with different devices, which shows how dependent the settling time can be on the device chosen.

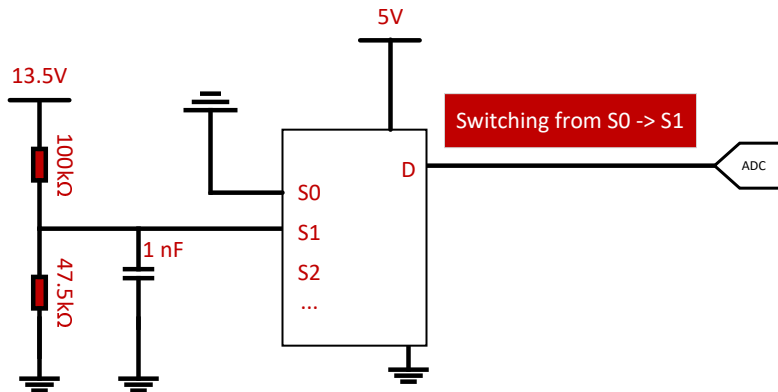


Figure 8-1. Test Circuit Setup

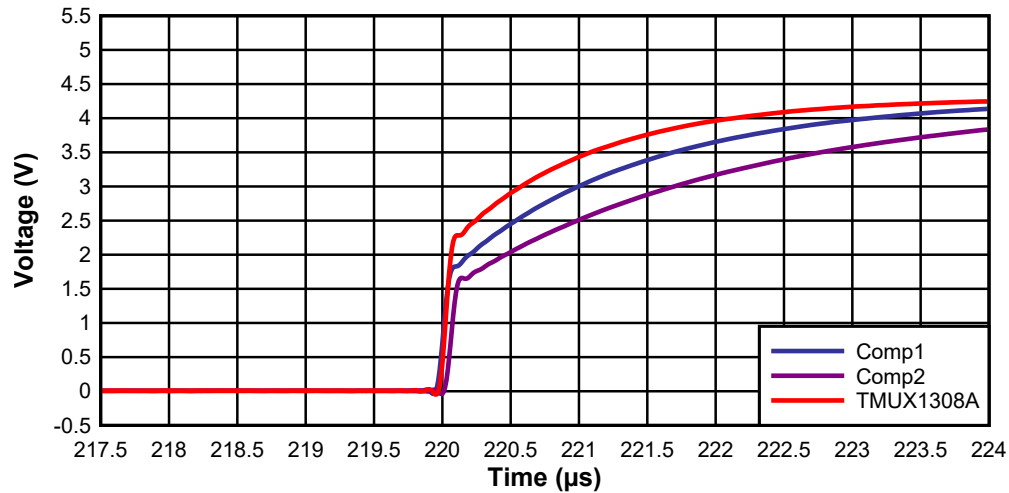


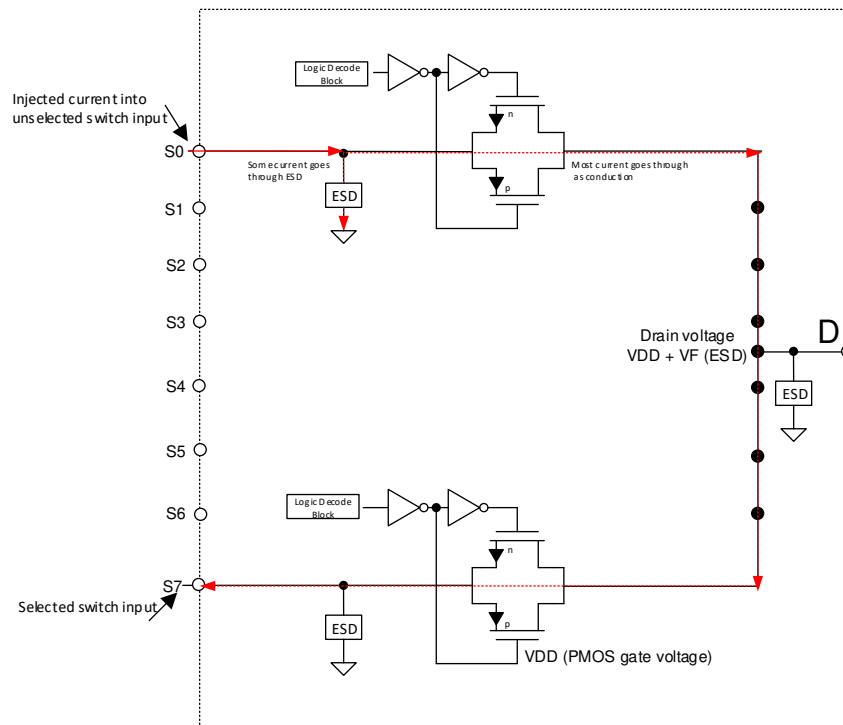
Figure 8-2. TMUX1308A vs. Competition Devices Drain Settling Times

### 8.3.6 Injection Current Control

On a high level, Injection current control is a feature that prevents an overvoltage event on an unactive channel from impacting the signal on an active one. The pin that experiences an overvoltage event will be held at  $V_{DD} + V_T$ , where  $V_T \cong 0.6V$ . The excess current caused by clamping this voltage will flow through an internal circuit that must remain within the current specifications of the device. By doing this, the device can prevent the excess current from injecting into the ON-channel causing errors in measurement. Injection current is the current that is being forced into a pin by an input voltage ( $V_{IN}$ ) higher than the positive supply ( $V_{DD} + \Delta V$ ) or lower than ground ( $V_{SS}$ ). The current flows through the input protection diodes into whichever supply of the device is potentially compromising the accuracy and reliability of the system. Injected currents can come from various sources depending on the application.

- Harsh environments and applications with long cabling, such as in factory automation and automotive systems, may be susceptible to injected currents from switching or transient events.
- Other self-contained systems can also be subject to injected current if the input signal is coming from various sensors or current sources.

**Injected Current Impact:** typical CMOS switches have ESD protection diodes on the inputs and outputs. These diodes not only serve as ESD protection but also provide a voltage clamp to prevent the inputs or outputs going above  $V_{DD}$  or below  $GND$  and  $V_{SS}$ . When current is injected into the pin of a disabled signal path, a small amount of current goes through the ESD diode but most of the current goes through conduction to the drain. If forward diode voltage of the ESD diode ( $V_F$ ) is greater than the PMOS threshold voltage ( $V_T$ ), then the PMOS of all OFF switches turns ON and there would be undesirable subthreshold leakage between the source and the drain that can lift the OFF source pins up also. [Figure 8-3](#) shows a simplified diagram of a typical CMOS switch and associated injected current path.



**Figure 8-3. Simplified Diagram of Typical CMOS Switch and Associated Injected Current Path**

It is quite difficult to cut off these current paths. The drain pin can never be allowed to exceed the voltage above  $V_{DD}$  by more than a  $V_T$ . Analog pins can be protected against current injection by adding external components like a Schottky diode from the drain pin to ground to clamp the drain voltage at  $< V_{DD} + V_T$  and cut off the current path.

**Change in  $R_{ON}$  due to Current Injection:** because the ON resistance of the enabled FET switch is impacted by the change in the supply rail, when the drain pin voltage exceeds the supply voltage by more than a  $V_T$ , an error in the output signal voltage can be expected. This undesired change in the output can cause issues related to false trigger events and incorrect measurement readings, potentially compromising the accuracy and reliability of the system. As shown in Figure 8-4, S2 is the enabled signal path that is conducting a signal from S2 pin to D pin. Because there is an injected current at the disabled S1 pin, the voltage at that pin increases above the supply voltage and the ESD protection diode is forward biased, shifting the power supply rail. This shift in supply voltage alters the  $R_{ON}$  of the internal FET switches, causing a  $\Delta V$  error on the output at the D pin.

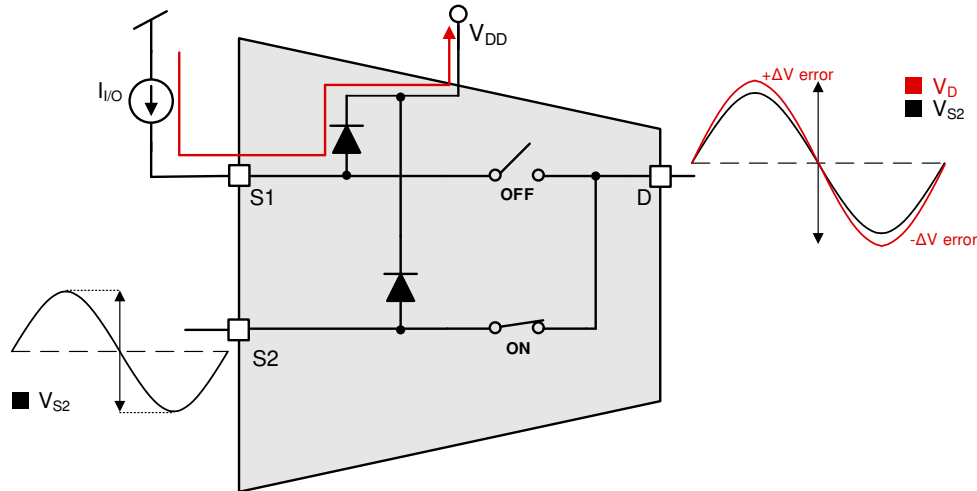


Figure 8-4. Injected Current Impact on  $R_{ON}$

To avoid the complications of added external protection to your system, the TMUX1308A and TMUX1309A devices have an internal injection current control feature which eliminates the need for external diode and resistor networks typically used to protect the switch and keep the input signals within the supply voltage. The internal injection current control circuitry allows the signals on the disabled signal paths to exceed the supply voltage without affecting the signal of the enabled signal path. The injection current control circuitry also protects the TMUX13xxA from currents injected into disabled signal paths without impacting the enabled signal path, which typical CMOS switches do not support. Additionally, the TMUX1308A and TMUX1309A do not have any internal diode paths to the supply pin, which eliminates the risk of damaging components connected to the supply pin or providing unintended power to the system supply rail. For a simplified diagram that shows one signal path for the TMUX13xxA devices and the associated injection current circuit, refer to Section 8.2.

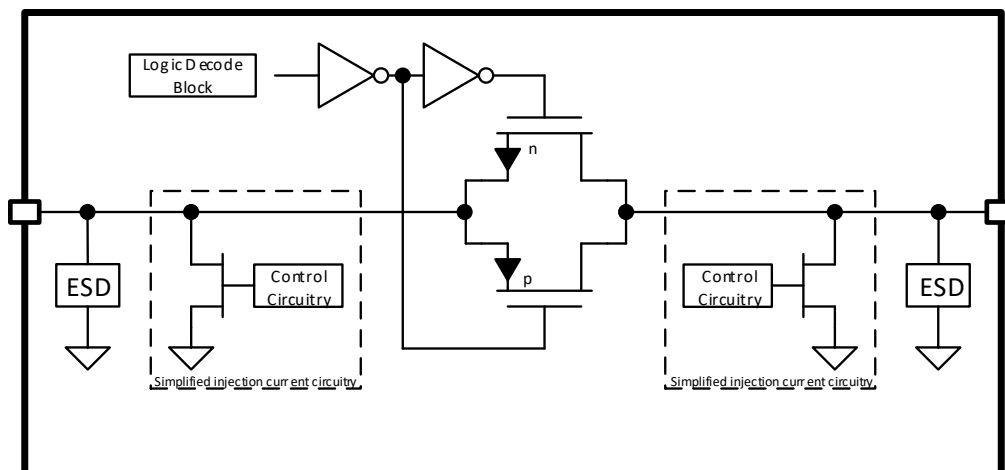


Figure 8-5. Simplified Diagram of Injection Current Control



The injection current control circuitry is independently controlled for each source or drain pin (Sx or D). The control circuitry for a particular pin is enabled when that input is disabled by the logic pins and the injected current causes the voltage at the pin to be above  $V_{DD}$  or below GND. The injection current circuit includes an FET to shunt the undesired current to GND in the case of overvoltage or injected current events. Each injection current circuit is rated to handle up to 50mA; the device, however, can support a maximum current of 100mA at any given time. Depending on the system application, a series limiting resistor may be needed and must be sized appropriately. Figure 8-5 shows the TMUX13xxA protection circuitry with an injected current at an input pin.

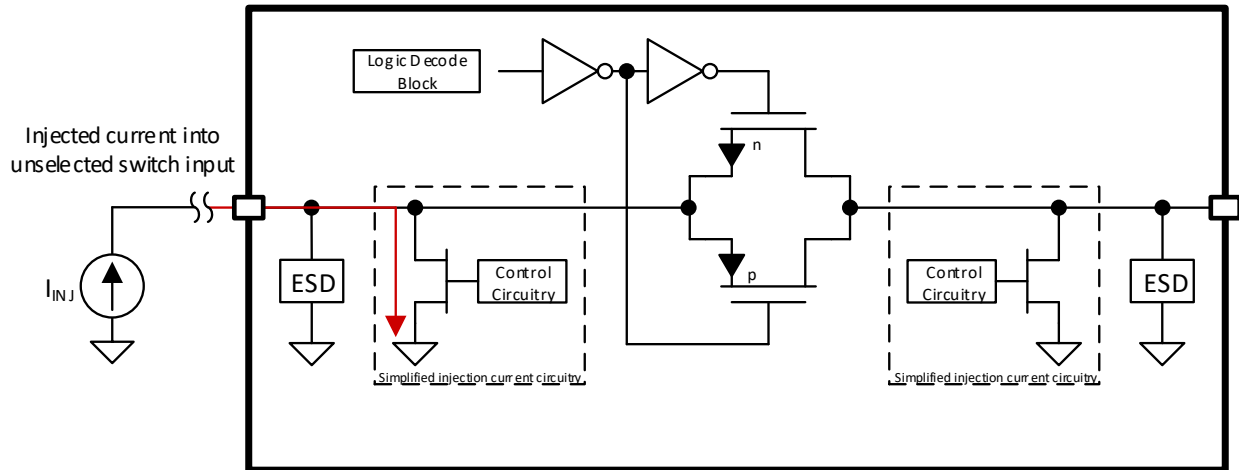


Figure 8-6. Injected Current at Input Pin

Figure 8-7 shows an example of using a series limiting resistor in the case of an overvoltage event.

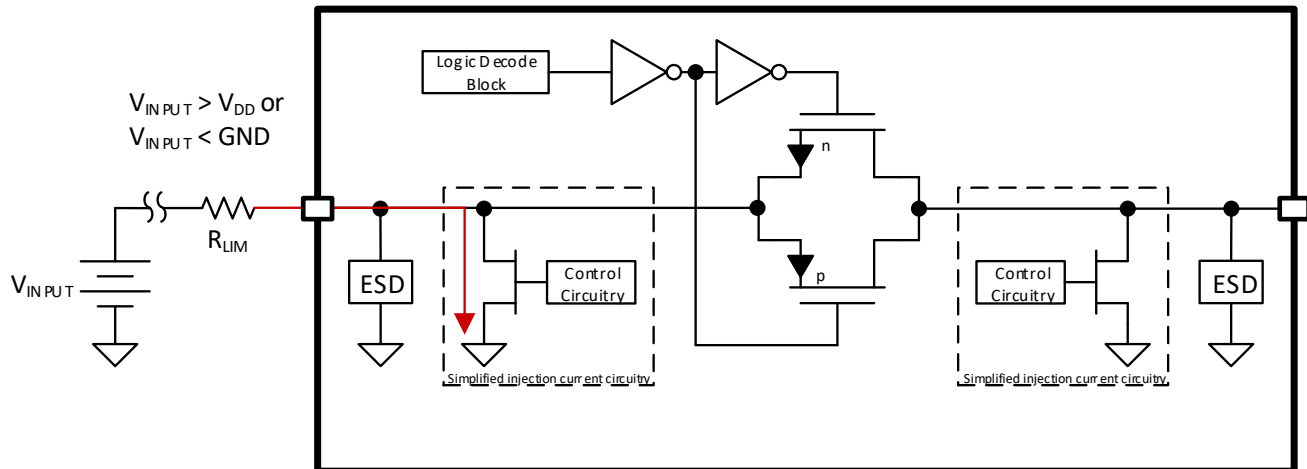


Figure 8-7. Over-Voltage Event with Series Resistor

For the injection current control circuitry to be active the voltage at the source or drain pins is greater than  $V_{DD}$ , or less than GND. With this requirement met, the protection FET will be turned on for any disabled or enabled signal path and shunt the pin to GND. In this event, a series resistor is needed to limit the total current injected into the device to be less than 100mA. Three example scenarios are outlined in the following sections.

**8.3.6.1 TMUX13xxA is Powered, Channel is Unselected, and the Input Signal is Greater Than  $V_{DD}$  ( $V_{DD} = 5V$ ,  $V_{INPUT} = 5.5V$ )**

A typical CMOS switch would have an internal ESD diode to the supply pin rated for  $\approx 30mA$  that would be turned on and a series limited resistor would be needed. However, any conducted current would be injected into the supply rail potentially damaging the system, unexpectedly turning on other devices on the same supply rail, or requiring additional components for protection. The TMUX13xxA implementation also handles this scenario with a series limiting resistor; the current path, however, is now to GND which does not have the same issues as the current injected into the supply rail.

**8.3.6.2 TMUX13xxA is Powered, Channel is Selected, and the Input Signal is Greater Than  $V_{DD}$  ( $V_{DD} = 5V$ ,  $V_{INPUT} = 5.5V$ )**

The injection current control circuitry is fully active when the channel is unselected and an overvoltage event is present (overvoltage being defined as 0.5V above the supply rail). However, in situations where the channel is selected and an overvoltage event occurs, this protection circuitry will still be partially active. In this instance, a portion of the injected current will be redirected through the protection circuitry to GND, but will not be a full shunt. So, some current will also flow through the source to drain path. This allows the device to tolerate overvoltage conditions in the event of the channel being selected, but precautions are still necessary to protect the device from overcurrent events such as implementing a current limiting resistor to keep the device below the maximum continuous source and drain current specification.

**8.3.6.3 TMUX13xxA is Unpowered and the Input Signal has a Voltage Present ( $V_{DD} = 0V$ ,  $V_{INPUT} = 3V$ )**

Many CMOS switches are unable to support a voltage at the input without a valid supply voltage present, otherwise the voltage will be coupled from input to output and could damage downstream devices or impact power-sequencing. The TMUX13xxA circuitry can handle an input signal present without a supply voltage while minimizing power transfer from the input to output of the switch. By limiting the output voltage coupling to 400 mV the TMUX1308A and TMUX1309A help reduce the chance of conduction through any downstream ESD diodes.

**8.4 Device Functional Modes**

When the  $\overline{EN}$  pin of the TMUX1308A is pulled low, one of the switches is closed based on the state of the address lines. Similarly, when the  $\overline{EN}$  pin of the TMUX1309A is pulled low, two of the switches are closed based on the state of the address lines. When the  $\overline{EN}$  pin is pulled high, all the switches are in an open state regardless of the state of the address lines.

Unused logic control pins must be tied to GND or  $V_{DD}$  so that the device does /not consume additional current as highlighted in [Implications of Slow or Floating CMOS Inputs](#). Unused signal path inputs (Sx and Dx) should be connected to GND.

**8.5 Truth Tables**

[Table 8-1](#) and [Table 8-2](#) provides the truth tables for the TMUX1308A and TMUX1309A respectively.

**Table 8-1. TMUX1308A Truth Table**

| EN | A2 | A1 | A0 | Selected Signal Path Connected To Drain (D) Pin |
|----|----|----|----|---|
| 0  | 0  | 0  | 0  | S0  |
| 0  | 0  | 0  | 1  | S1  |
| 0  | 0  | 1  | 0  | S2  |
| 0  | 0  | 1  | 1  | S3  |
| 0  | 1  | 0  | 0  | S4  |
| 0  | 1  | 0  | 1  | S5  |
| 0  | 1  | 1  | 0  | S6  |
| 0  | 1  | 1  | 1  | S7  |

**Table 8-1. TMUX1308A Truth Table (continued)**

| $\overline{EN}$ | A2               | A1               | A0               | Selected Signal Path Connected To Drain (D) Pin |
|-----------------|------------------|------------------|------------------|---|
| 1               | X <sup>(1)</sup> | X <sup>(1)</sup> | X <sup>(1)</sup> | All channels are off                            |

(1) X denotes *do not care*.

**Table 8-2. TMUX1309A Truth Table**

| $\overline{EN}$ | A1               | A0               | Selected Signal Path Connected To Drain (DA and DB) Pins |
|-----------------|------------------|------------------|--|
| 0               | 0                | 0                | S0A to DA<br>S0B to DB                                   |
| 0               | 0                | 1                | S1A to DA<br>S1B to DB                                   |
| 0               | 1                | 0                | S2A to DA<br>S2B to DB                                   |
| 0               | 1                | 1                | S3A to DA<br>S3B to DB                                   |
| 1               | X <sup>(1)</sup> | X <sup>(1)</sup> | All channels are off                                     |

(1) X denotes *do not care*.

## 9 Application and Implementation

### Note

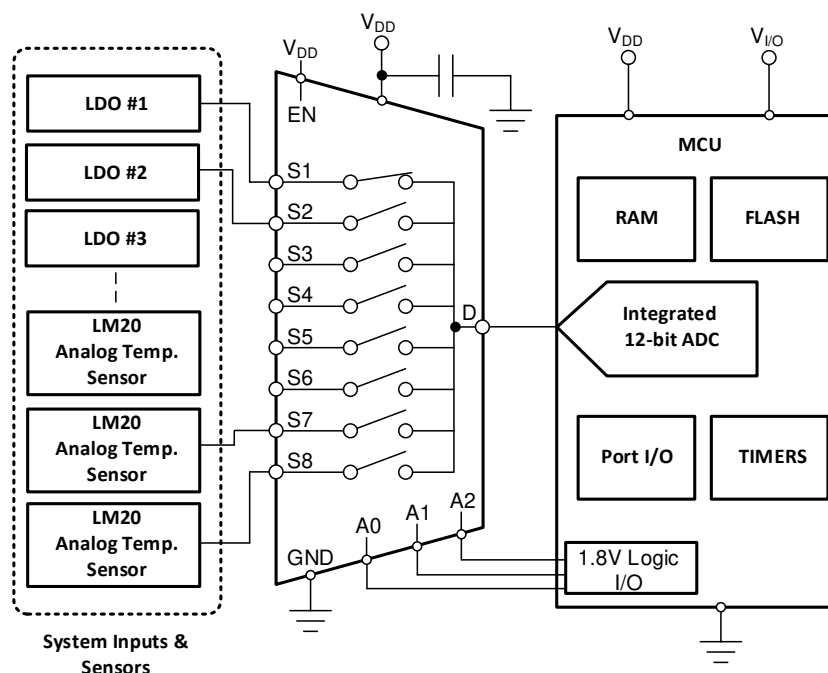
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

The TMUX13xxA family offers protection against injection current events across a wide operating supply range (1.62V to 5.5V). These devices include 1.8V logic compatible control input pins that enable operation in systems with 1.8V I/O rails. Additionally, the control input pins support Fail-Safe Logic which allows for operation up to 5.5V, regardless of the state of the supply pin. This feature stops the logic pins from back-powering the supply rail while the injection current circuitry prevents the signal path from back-powering the supply. These features make the TMUX13xxA a family of general purpose multiplexers and switches that can reduce system complexity, board size, and overall system cost.

### 9.2 Typical Application

One useful application that takes advantage of the TMUX13xxA features is multiplexing various signals into an ADC that is integrated into an MCU. Utilizing an integrated ADC in an MCU allows a system to minimize cost with a potential tradeoff of system performance when compared to an external ADC. The multiplexer allows for multiple inputs or sensors to be monitored with a single ADC pin of the device, which is critical in systems with limited I/O. The TMUX1309A is an excellent choice for a similar design example using differential signals, or as two 4:1 multiplexers.



**Figure 9-1. Multiplexing Signals to Integrated ADC**

### 9.2.1 Design Requirements

For this design example, use the parameters listed in [Table 9-1](#).

**Table 9-1. Design Parameters**

| PARAMETERS               | VALUES                        |
|--------------------------|-------------------------------|
| Supply ( $V_{DD}$ )      | 5.0V                          |
| I/O signal range         | 0V to $V_{DD}$ (Rail to Rail) |
| Control logic thresholds | 1.8V compatible               |
| Switch inputs            | Eight                         |

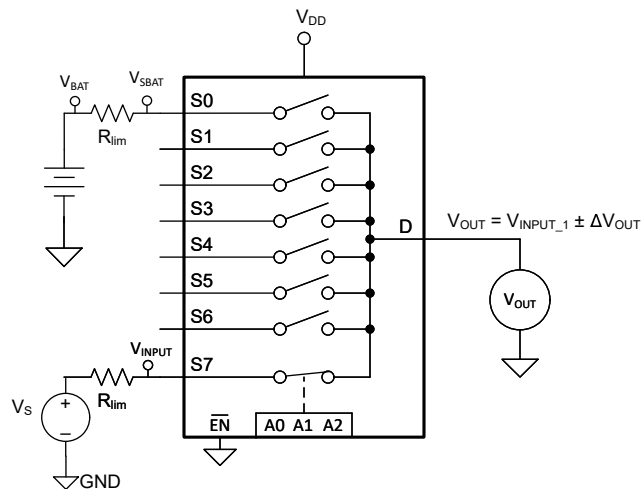
### 9.2.2 Detailed Design Procedure

The TMUX1308A and TMUX1309A can operate without any external components except for the supply decoupling capacitors. If the parts desired power-up state is disabled, then the enable pin should have a weak pull-up resistor and be controlled by the MCU through the GPIO. All inputs being muxed to the ADC of the MCU must fall within the recommended operating conditions of the TMUX1308A and TMUX1309A, including signal range and continuous current. For this design with a supply of 5 V, the signal range can be 0 V to 5 V; the maximum continuous current can be 100mA at an ambient temperature of 85°C or 25mA at 125°C.

### 9.2.3 Short To Battery Protection

When evaluating the safety and reliability of an automotive grade multiplexer, it is important to note their performance under various operating conditions. In the case of TMUX13xxA, we examine its response to various short-to-battery conditions to provide insight on system level design for automotive optimization. It is important to design around short-to-battery as failure to do so can result in operational issues. The following section shows a deep dive into three scenarios to demonstrate the behavior of the TMUX1308A under short-to-battery conditions using a 5V supply voltage.

We begin with the following setup to explore our first scenario with channel S7 selected and channel S0 experiencing a short-to-battery condition.



**Figure 9-2. Channel S7 Selected, Channel S0 Experiencing a Short-to-Battery Condition**

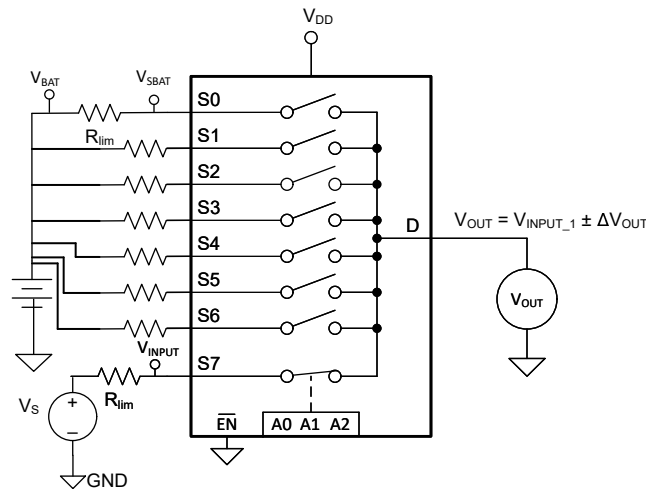
[Table 9-2](#) indicates values of  $\Delta V_{OUT}$ ,  $V_{SBAT}$  and minimum  $R_{LIM}$  for various  $V_{BAT}$  cases when considering a maximum allotment of 25mA for  $I_S/I_D$ . Choosing too large of an  $R_{LIM}$  will negatively affect  $\Delta V_{OUT}$  as well as substantially limit current flow. Choosing too small of an  $R_{LIM}$  can damage the device.

**Table 9-2.  $R_{LIM}$  Values for 25mA Through the Switch**

| $V_{BAT}$ | $R_{LIM}$ | $\Delta V_{OUT}$ (typ) | $V_{SBAT}$ |
|-----------|-----------|------------------------|------------|
| 12V       | 470       | < 10 $\mu$ V           | 5.6V       |

**Table 9-2. R<sub>LIM</sub> Values for 25mA Through the Switch (continued)**

| V <sub>BAT</sub> | R <sub>LIM</sub> | ΔV <sub>OUT</sub> (typ) | V <sub>SBAT</sub> |
|------------------|------------------|-------------------------|-------------------|
| 19V              | 750              | < 10μV                  | 5.6V              |
| 24V              | 1K               | < 10μV                  | 5.6V              |
| 36V              | 1.5K             | < 10μV                  | 5.6V              |
| 48V              | 2K               | < 10μV                  | 5.6V              |
| 60V              | 2.4K             | < 10μV                  | 5.6V              |



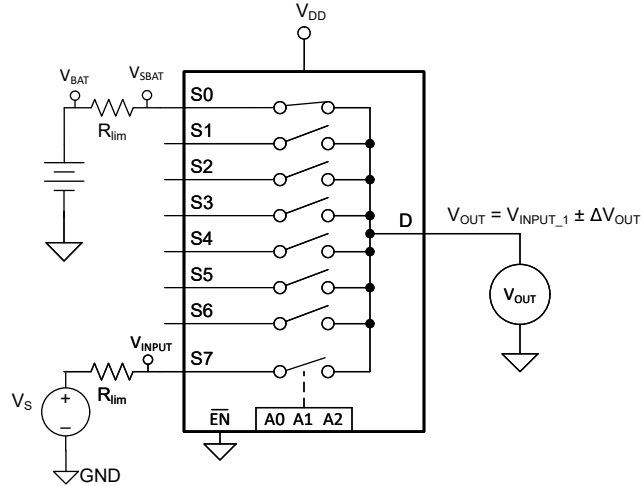
**Figure 9-3. All Unselected Channels Experiencing a Short-to-Battery Condition**

We then evaluate the scenario of seeing a short-to-battery condition on all unselected channels at the same time. The following table indicates values when considering a maximum allotment of 12.5mA for I<sub>S</sub>/I<sub>D</sub>(for more information, see Section 6.1). If you have the potential to see short-to-battery on all channels at the same time, then 12.5mA is the limiting factor. Here again choosing too large of an R<sub>LIM</sub> will negatively affect ΔV<sub>OUT</sub> as well as substantially limit current flow.

**CAUTION**  
To avoid damage to the device do not choose too small of an R<sub>LIM</sub>.

**Table 9-3. R<sub>LIM</sub> Values for 12.5mA Through the Switch**

| V <sub>BAT</sub> | R <sub>LIM</sub> | ΔV <sub>OUT</sub> (typ) | V <sub>SBAT</sub> |
|------------------|------------------|-------------------------|-------------------|
| 12V              | 1K               | < 10μV                  | 5.6V              |
| 19V              | 1.5K             | < 10μV                  | 5.6V              |
| 24V              | 2K               | < 10μV                  | 5.6V              |
| 36V              | 3K               | < 10μV                  | 5.6V              |
| 48V              | 3.9K             | < 10μV                  | 5.6V              |
| 60V              | 4.7K             | < 10μV                  | 5.6V              |



**Figure 9-4. Short-to-Battery Condition Only on a Single Selected Channel**

Evaluate the scenario of a short-to-battery occurring when the switch is closed using a 5V supply. As such, input voltage needs to be limited to 6V. The following table indicates values of  $R_{LIM}$  needed to keep the voltage of a selected channel under 6V using a standard 5V  $V_{DD}$  for all short-to-battery cases (for more information, see Section 6.1). Choosing too large of an  $R_{LIM}$  will negatively affect  $\Delta V_{OUT}$  as well as substantially limit current flow.

**CAUTION**

To avoid damage to the device do not choose too small of an  $R_{LIM}$ .

**Table 9-4.  $R_{LIM}$  Values for <6V Through the Switch**

| $V_{BAT}$ | $R_{LIM}$ | $\Delta V_{OUT}$ (typ) | $V_{SBAT}$ |
|-----------|-----------|------------------------|------------|
| 12V       | 1.6K      | < 10 $\mu$ V           | 5.9V       |
| 18V       | 3K        | < 10 $\mu$ V           | 5.9V       |
| 19V       | 3.3K      | < 10 $\mu$ V           | 5.9V       |
| 24V       | 4.7K      | < 10 $\mu$ V           | 5.9V       |
| 36V       | 10K       | < 10 $\mu$ V           | 5.9V       |
| 48V       | 13K       | < 10 $\mu$ V           | 5.9V       |
| 60V       | 15K       | < 10 $\mu$ V           | 5.9V       |

In conclusion, several short-to-battery case studies were observed using a 5V supply. Note that if using a lower supply voltage, the  $R_{LIM}$  values will change for optimal current flow. It is important to protect against short-to-battery conditions as a failure to do so can result in system level issues. Take care to design around these conditions and the electrical characteristics for proper device operation.

## 9.2.4 Application Curve

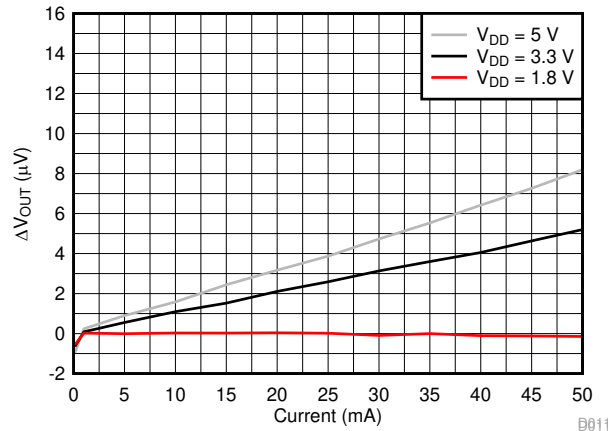


Figure 9-5. Injection Current vs. Maximum Output Voltage Shift

## 9.3 Power Supply Recommendations

The TMUX1308A and TMUX1309A devices operate across a wide supply range of 1.62V to 5.5V. Note: do not exceed the absolute maximum ratings because stresses beyond the listed ratings can cause permanent damage to the devices.

Power-supply bypassing improves noise margin and prevents switching noise propagation from the  $V_{DD}$  supply to other components. Good power-supply decoupling is important to achieve optimum performance. For improved supply noise immunity, use a supply decoupling capacitor ranging from 0.1 $\mu F$  to 10 $\mu F$  from  $V_{DD}$  to ground. Place the bypass capacitors as close to the power supply pins of the device as possible using low-impedance connections.

TI recommends using multi-layer ceramic chip capacitors (MLCCs) that offer low equivalent series resistance (ESR) and inductance (ESL) characteristics for power-supply decoupling purposes. For very sensitive systems, or for systems in harsh noise environments, avoiding the use of vias for connecting the capacitors to the device pins may offer superior noise immunity. The use of multiple vias in parallel lowers the overall inductance and is beneficial for connections to ground planes.

## 9.4 Layout

### 9.4.1 Layout Guidelines

When a PCB trace turns a corner at a 90° angle, a reflection can occur. A reflection occurs primarily because of the change of width of the trace. At the apex of the turn, the trace width increases to 1.414 times the width. This increase upsets the transmission-line characteristics, especially the distributed capacitance and self-inductance of the trace which results in the reflection. Not all PCB traces can be straight; therefore, some traces must turn corners. Figure 9-6 shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.



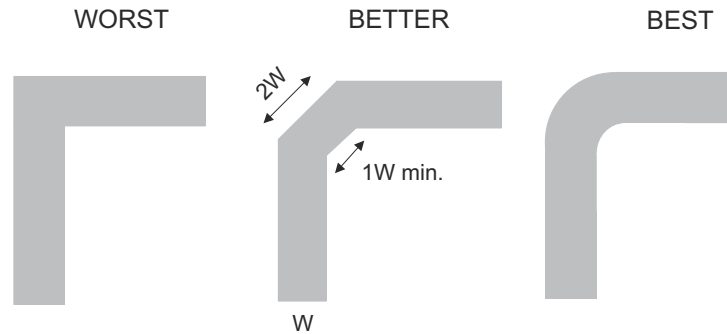


Figure 9-6. Trace Example

Route high-speed signals using a minimum of vias and corners which reduces signal reflections and impedance changes. When a via must be used, increase the clearance size around it to minimize its capacitance. Each via introduces discontinuities in the signal's transmission line and increases the chance of picking up interference from the other layers of the board. Be careful when designing test points, through-hole pins are not recommended at high frequencies.

Figure 9-7 shows an example of a PCB layout with the TMUX1308A and TMUX1309A. Some key considerations are as follows:

- Decouple the  $V_{DD}$  pin with a 0.1- $\mu\text{F}$  capacitor, placed as close to the pin as possible. Make sure that the capacitor voltage rating is sufficient for the  $V_{DD}$  supply.
- Keep the input lines as short as possible.
- Use a solid ground plane to help reduce electromagnetic interference (EMI) noise pickup.
- Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if possible, and only make perpendicular crossings when necessary.

#### 9.4.2 Layout Example

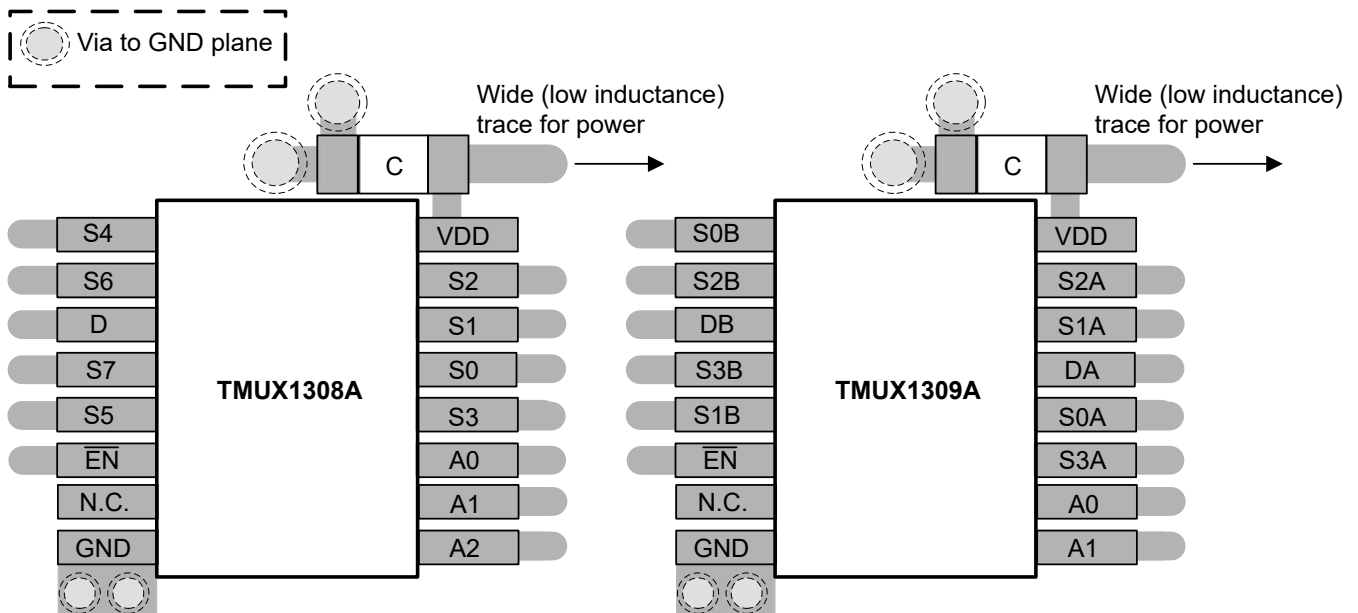


Figure 9-7. TMUX1308A and TMUX1309A Layout Example

## 10 Device and Documentation Support

### 10.1 Documentation Support

#### 10.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, [Simplifying Design with 1.8V logic Muxes and Switches](#)
- Texas Instruments, [QFN/SON PCB Attachment](#)
- Texas Instruments, [Quad Flatpack No-Lead Logic Packages](#)

### 10.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 10.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

### 10.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

### 10.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 10.6 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

## 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## 12 Revision History

| DATE      | REVISION | NOTES           |
|-----------|----------|-----------------|
| June 2024 | *        | Initial Release |

**PACKAGING INFORMATION**

| Orderable Device | Status<br>(1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan<br>(2) | Lead finish/<br>Ball material<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples                 |
|------------------|---------------|--------------|-----------------|------|-------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| TMUX1308APWR     | ACTIVE        | TSSOP        | PW              | 16   | 2000        | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 125   | 1308A                   | <a href="#">Samples</a> |
| TMUX1309APWR     | ACTIVE        | TSSOP        | PW              | 16   | 2000        | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 125   | 1309A                   | <a href="#">Samples</a> |

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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**OTHER QUALIFIED VERSIONS OF TMUX1308A, TMUX1309A :**

- Automotive : [TMUX1308A-Q1](#), [TMUX1309A-Q1](#)

## NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

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